

TI Designs: TIDA-010039

Three-Level, Three-Phase SiC AC-to-DC Converter Reference Design



Description

This reference design provides an overview on how to implement a three-level, three-phase, SiC-based AC/DC converter with bidirectional functionality. A high switching frequency of 50 kHz reduces the size of magnetics for the filter design and as a result a higher power density. SiC MOSFETs with low switching loss enable higher DC bus voltages of up to 800 V and lower switching losses with a peak efficiency of > 97%. This design is configurable to work as a two-level or three-level rectifier. For design information on the DC/AC implementation, see [TIDA-01606](#).

Resources

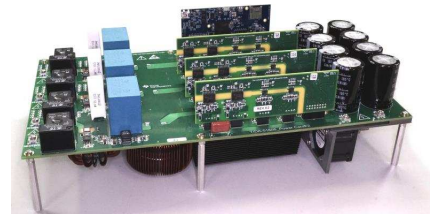
TIDA-010039	Design Folder
ISO5852S	Product Folder
UCC5320	Product Folder
TMDSCNCD28379D	Tool Folder
AMC1306M05	Product Folder
OPA4340	Product Folder
LM76003	Product Folder
PTH08080W	Product Folder
TLV1117LV	Product Folder
OPA350	Product Folder
UCC27211	Product Folder

Features

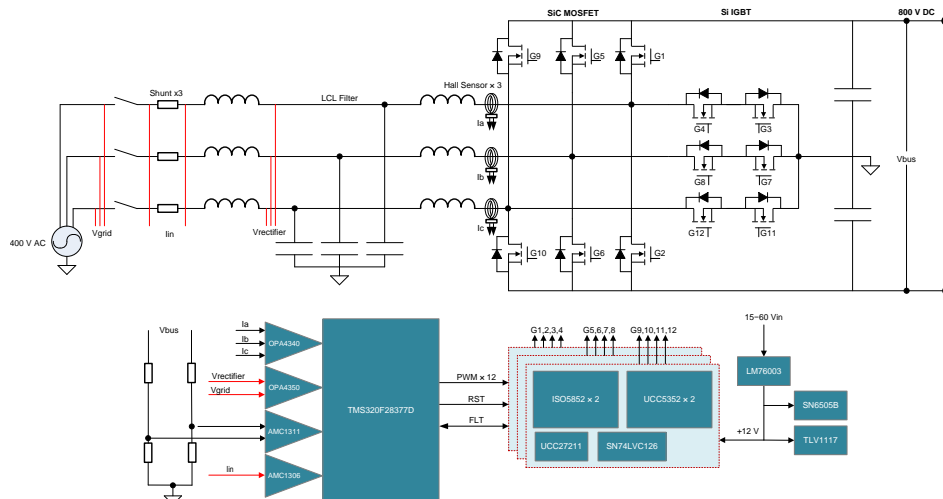
- Rated nominal input of 380–400 VAC peak, with DC output of 800 V
- Maximum 10-kW, 10-kVA output power at 400-VAC 50- or 60-Hz grid connection
- High-voltage (1200 V) SiC MOSFET-based full-bridge AC/DC converter for peak efficiency of > 97%
- Compact filter by switching rectifier at 50 kHz
- Isolated driver ISO5852S with reinforced isolation for driving high-voltage SiC MOSFET and UCC5320S for driving middle Si IGBT
- Isolated current sensing using the AMC1301 for load current monitoring
- TMS320F28379D control card for digital control

Applications

- [DC Charging \(Pile\) Station](#)
- [EV Charging Station Power Module](#)
- [Energy Storage Power Conversion System \(PCS\)](#)
- [Three Phase UPS](#)



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1 System Description

Newer generations of Electric Vehicles (EVs) are pushing the battery capacity and charging rates higher and higher to meet consumer demand for longer range and less time spent with the vehicle plugged in. To support these new trends, EV charging stations need to supply more power than ever before.

In addition to higher power levels, additional trends in the EV charging market are pushing the technology in other fronts:

1. Higher voltage batteries
2. Bidirectional power flow
3. Increased power density

By increasing battery voltage, more power to the vehicle can be realized at the same current levels. This also maintains or reduces the amount of copper and results in smaller power devices required in the power stages of the charging station. The reduction in di/dt also reduces the stress on electrical components. However, sustained DC voltages of > 800 V can be difficult to design to, or even find components that can survive it, especially in high switch frequency designs.

Bidirectional power flow from the grid to the battery, and battery to grid, is enabling the battery of the vehicle to serve as a distributed energy resource. This allows for grid load balancing when renewable resources are low, or to accommodate demand shift throughout the day.

To compensate for the voltage stresses generated by high-voltage batteries, and enable bidirectional power flow, new topologies of converters have been designed. Traditional half bridges block the full input voltage on each switching device. By adding additional switched blocking and conduction components, the overall stress on the device can be significantly reduced. This reference design shows how to implement a three-level converter. Higher level converters are also possible, further increasing the voltage handling capability.

Additional power density in power electronics is also being enabled by moving to higher switching speeds in the power converters. As this design shows, even a modestly higher switching speed reduces the overall size requirement of the output filter stage—a primary contributor to the design size.

Traditional switching devices have a limit in how quickly they can switch high voltages, or more appropriately, the dV/dt ability of the device. This slow ramp up and down increases switching loss because the device spends more time in a switching state. This increased switch time also increases the amount of dead time required in the control system to prevent shoot-through and shorts. The solution to this has been developed in newer switching semiconductor technology like SiC and GaN devices with high electron mobility. This reference design uses SiC MOSFETs alongside TI's SiC gate driver technology to demonstrate the potential increase in power density.

1.1 Key System Specifications

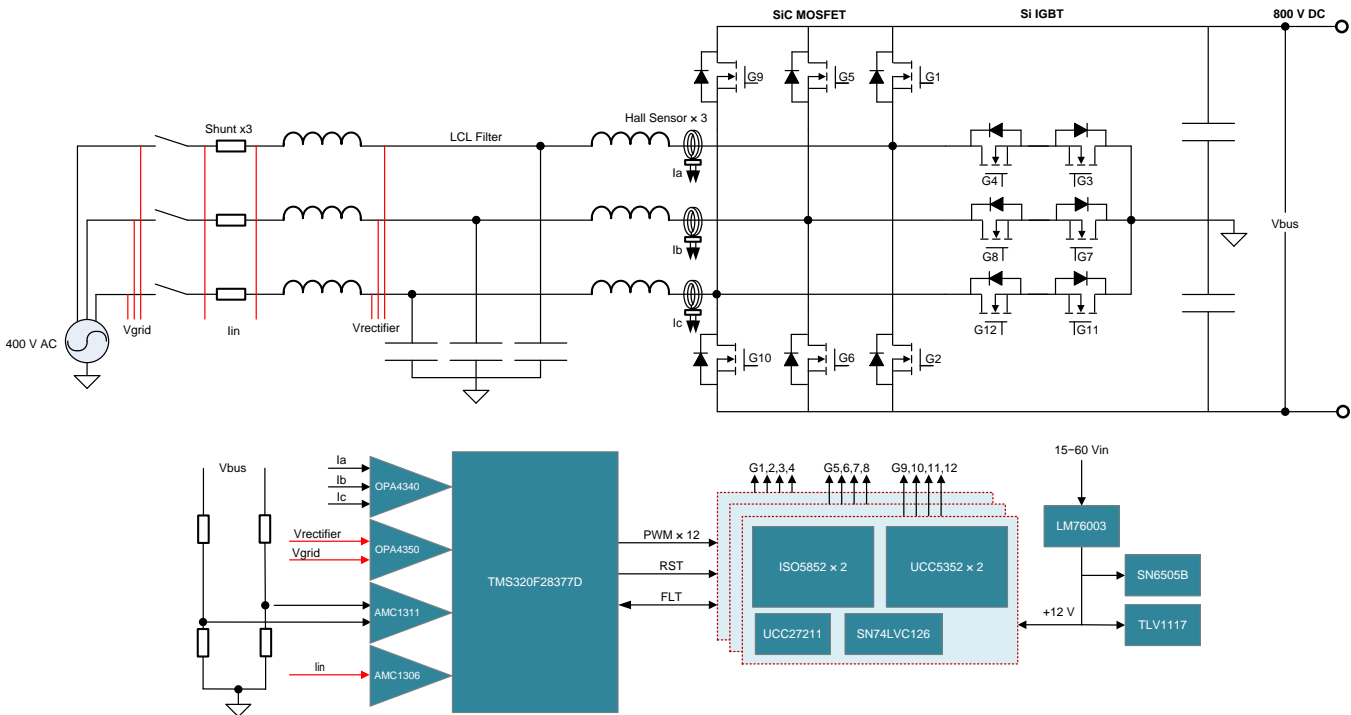
Table 1. Key System Specifications

PARAMETER	SPECIFICATIONS	DETAILS
Output power	10 kW	Section 2.3
Nominal DC link voltage	800 VDC (100 V Max)	Section 2.3
AC frequency	50 or 60 Hz	Section 2.3
DC current	12.5 A Nominal	Section 2.3
Nominal AC voltage	400 VAC	Section 2.3
Switching frequency	50 kHz	Section 2.3
Efficiency	99%	Section 2.3.1.5
Power density	1 kW/L+	

2 System Overview

2.1 Block Diagram

Figure 1. TIDA-010039 Block Diagram



This reference design is comprised of four separate boards that intercommunicate. The following boards work in tandem to form this three-phase converter reference design:

- A power board, comprising all of the switching device, LCL filter, sensing electronics, and power structure
- A TMS320F28377D Control Card to support the DSP
- Three gate driver cards, each with two ISO5852S and two UCC5320 gate drivers
- A high-voltage, isolated DC link voltage sensing card using the AMC1311 device

2.2 Highlighted Products

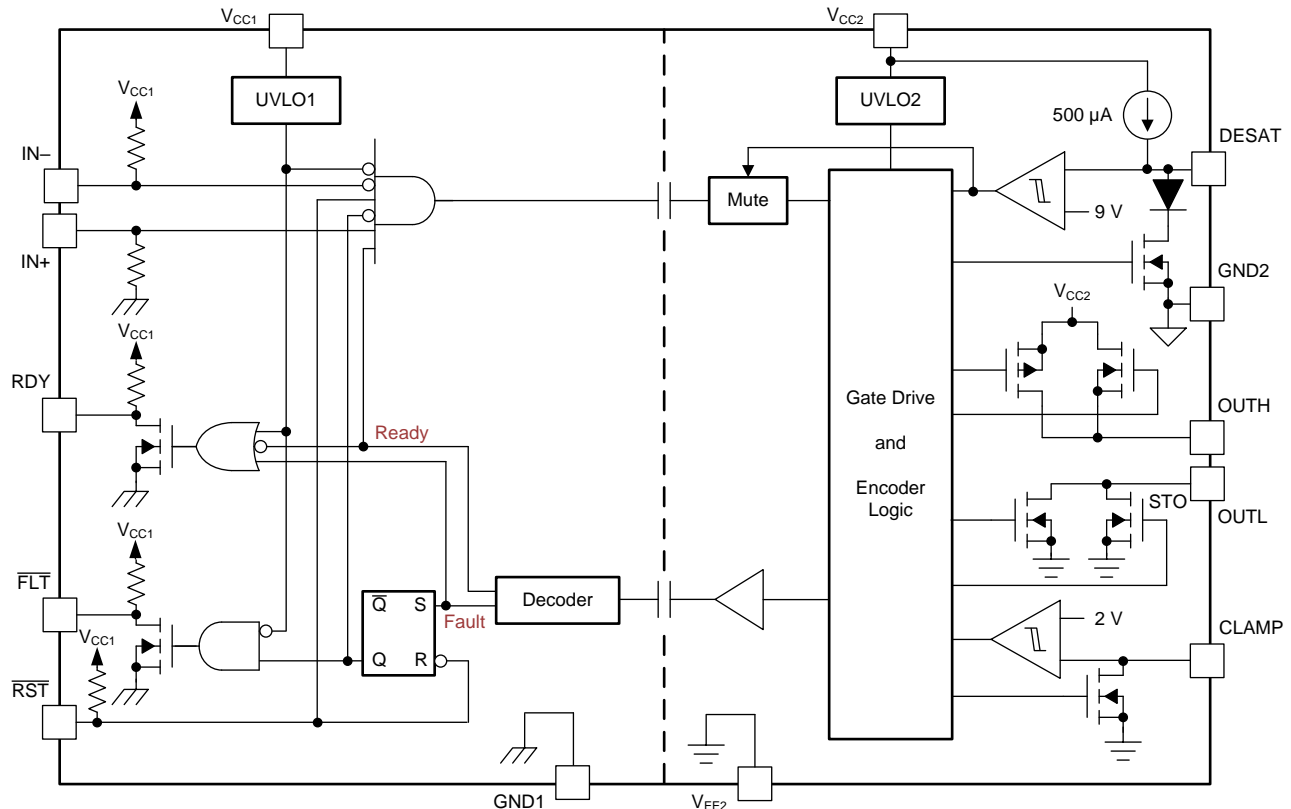
2.2.1 ISO5852S

The ISO5852S device is a 5.7-kV_{RMS}, reinforced isolated gate driver for IGBTs and MOSFETs with split outputs, OUTH and OUTL, providing 2.5-A source and 5-A sink current. The input side operates from a single 2.25-V to 5.5-V supply. The output side allows for a supply range from minimum 15 V to maximum 30 V. Two complementary CMOS inputs control the output state of the gate driver. The short propagation time of 76 ns provides accurate control of the output stage.

- 100-kV/μs minimum common-mode transient immunity (CMTI) at $V_{CM} = 1500$ V
- Split outputs to provide 2.5-A peak source and 5-A peak sink currents
- Short propagation delay: 76 ns (typ), 110 ns (max)
- 2-A active Miller clamp
- Output short-circuit clamp
- Soft turnoff (STO) during short circuit
- Fault alarm upon desaturation detection is signaled on FLT and reset through RST
- Input and output undervoltage lockout (UVLO) with Ready (RDY) pin indication

- Active output pulldown and default low outputs with low supply or floating inputs
- 2.25-V to 5.5-V input supply voltage
- 15-V to 30-V output driver supply voltage
- CMOS compatible inputs
- Rejects input pulses and noise transients shorter than 20 ns
- Operating temperature: -40°C to $+125^{\circ}\text{C}$ ambient
- Isolation surge withstand voltage of $12800\text{-}V_{\text{PK}}$

Figure 2. ISO5852S Functional Block Diagram



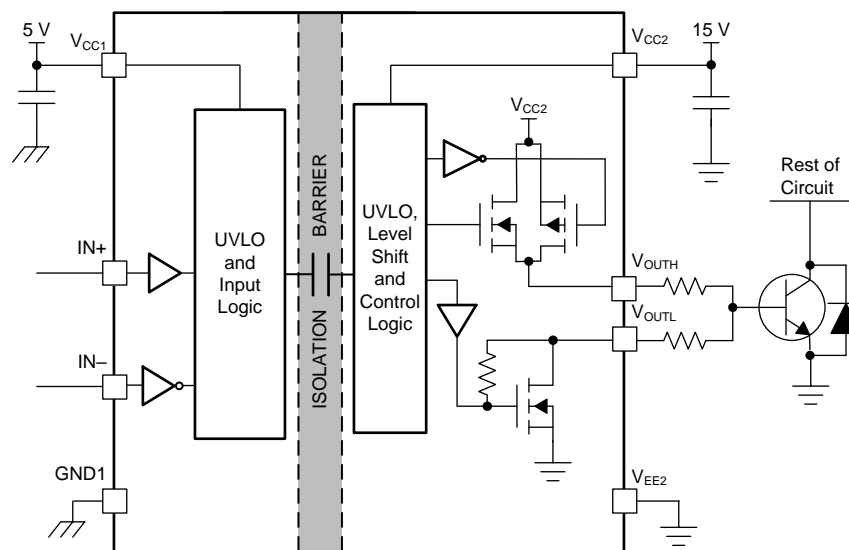
2.2.2 UCC5320

The UCC53x0 is a family of compact, single-channel, isolated IGBT, SiC, and MOSFET gate drivers with superior isolation ratings and variants for pinout configuration, and drive strength.

The UCC53x0 is available in an 8-pin SOIC (D) package. This package has a creepage and clearance of 4 mm and can support isolation voltage up to 3 kV_{RMS} , which is good for applications where basic isolation is needed. With these various options and wide power range, the UCC53x0 family is a good fit for motor drives and industrial power supplies.

- 3-V to 15-V input supply voltage
- 13.2-V to 33-V output driver supply voltage
- Feature options:
 - Split outputs (UCC5320S and UCC5390S)
 - UVLO with respect to IGBT emitter (UCC5320E and UCC5390E)
 - Miller clamp option (UCC5310M and UCC5350M)
- Negative 5-V handling capability on input pins
- 60-ns (typical) propagation delay for UCC5320S, UCC5320E, and UCC5310M
- 100-kV/ μs minimum CMTI

- Isolation surge withstand voltage: 4242 V_{PK}
- Safety-related certifications:
 - 4242-V_{PK} isolation per DIN V VDE V 0884-10 and DIN EN 61010-1 (planned)
 - 3000-V_{RMS} isolation for 1 minute per UL 1577 (planned)
 - CSA Component Acceptance Notice 5A, IEC 60950-1 and IEC 61010-1 End Equipment Standards (Planned)
 - CQC Certification per GB4943.1-2011 (Planned)
- 4-kV ESD on all pins
- CMOS inputs
- 8-pin narrow body SOIC package
- Operating temperature: –40°C to +125°C ambient

Figure 3. UCC5320 Functional Block Diagram (S Version)


2.2.3 TMS320F28379D

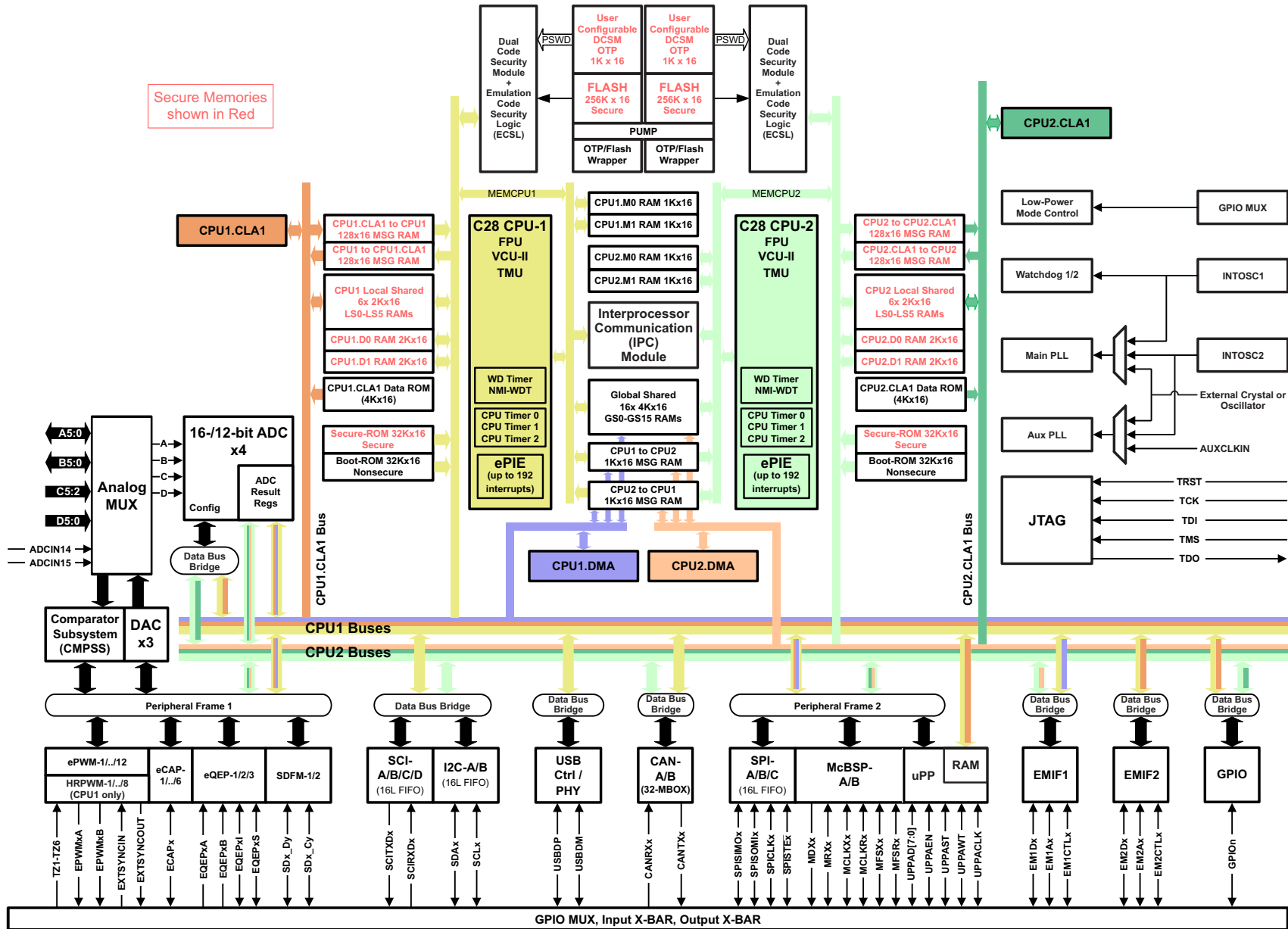
The Delfino™ TMS320F2837xD is a powerful 32-bit floating-point microcontroller unit (MCU) designed for advanced closed-loop control applications such as industrial drives and servo motor control; solar inverters and converters; digital power; transportation; and power line communications. Complete development packages for digital power and industrial drives are available as part of the powerSUITE and DesignDRIVE initiatives. While the Delfino product line is not new to the TMS320C2000™ portfolio, the F2837xD supports a new dual-core C28x architecture that significantly boosts system performance. The integrated analog and control peripherals also let designers consolidate control architectures and eliminate multiprocessor use in high-end systems.

- Dual-core architecture:
 - Two TMS320C28x 32-bit CPUs
 - 200 MHz
 - IEEE 754 single-precision floating-point unit (FPU)
 - Trigonometric math unit (TMU)
 - Viterbi/complex math unit (VCU-II)
- Two programmable control law accelerators (CLAs)
 - 200 MHz
 - IEEE 754 single-precision floating-point instructions
 - Executes code independently of main CPU

- On-chip memory
 - 512KB (256 kW) or 1MB (512 kW) of Flash (ECC-protected)
 - 172KB (86 kW) or 204KB (102 kW) of RAM (ECC-protected or parity-protected)
 - Dual-zone security supporting third-party development
- Clock and system control:
 - Two internal zero-pin 10-MHz oscillators
 - On-chip crystal oscillator
 - Windowed watchdog timer module
 - Missing clock detection circuitry
- 1.2-V core, 3.3-V I/O design
- System peripherals:
 - Two external memory interfaces (EMIFs) with ASRAM and SDRAM support
 - Dual six-channel direct memory access (DMA) controllers
 - Up to 169 individually programmable, multiplexed general-purpose input/output (GPIO) pins with input filtering
 - Expanded peripheral interrupt controller (ePIE)
 - Multiple low-power mode (LPM) support with external wakeup
- Communications peripherals:
 - USB 2.0 (MAC + PHY)
 - Support for 12-pin 3.3-V compatible universal parallel port (uPP) interface
 - Two controller area network (CAN) modules (pin-bootable)
 - Three high-speed (up to 50-MHz) SPI ports (pin-bootable)
 - Two multichannel buffered serial ports (McBSPs)
 - Four serial communications interfaces (SCI/UART) (pin-bootable)
 - Two I²C interfaces (pin-bootable)
- Analog subsystem:
 - Up to four analog-to-digital converters (ADCs):
 - 16-bit mode
 - 1.1 MSPS each (up to 4.4-MSPS system throughput)
 - Differential inputs
 - Up to 12 external channels
 - 12-bit mode
 - 3.5 MSPS each (up to 14-MSPS system throughput)
 - Single-ended inputs
 - Up to 24 external channels
 - Single sample-and-hold (S/H) on each ADC
 - Hardware-integrated post-processing of ADC conversions:
 - Saturating offset calibration
 - Error from setpoint calculation
 - High, low, and zero-crossing compare, with interrupt capability
 - Trigger-to-sample delay capture
 - Eight windowed comparators with 12-bit digital-to-analog converter (DAC) references
 - Three 12-bit buffered DAC outputs
- Enhanced control peripherals:
 - 24 pulse width modulator (PWM) channels with enhanced features
 - 16 high-resolution pulse width modulator (HRPWM) channels:

- High resolution on both A and B channels of eight PWM modules
- Dead-band support (on both standard and high resolution)
- Six enhanced capture (eCAP) modules
- Three enhanced quadrature encoder pulse (eQEP) modules
- Eight sigma-delta filter module (SDFM) input channels, two parallel filters per channel:
 - Standard SDFM data filtering
 - Comparator filter for fast action for out of range

Figure 4. TMS320F28377D Functional Block Diagram



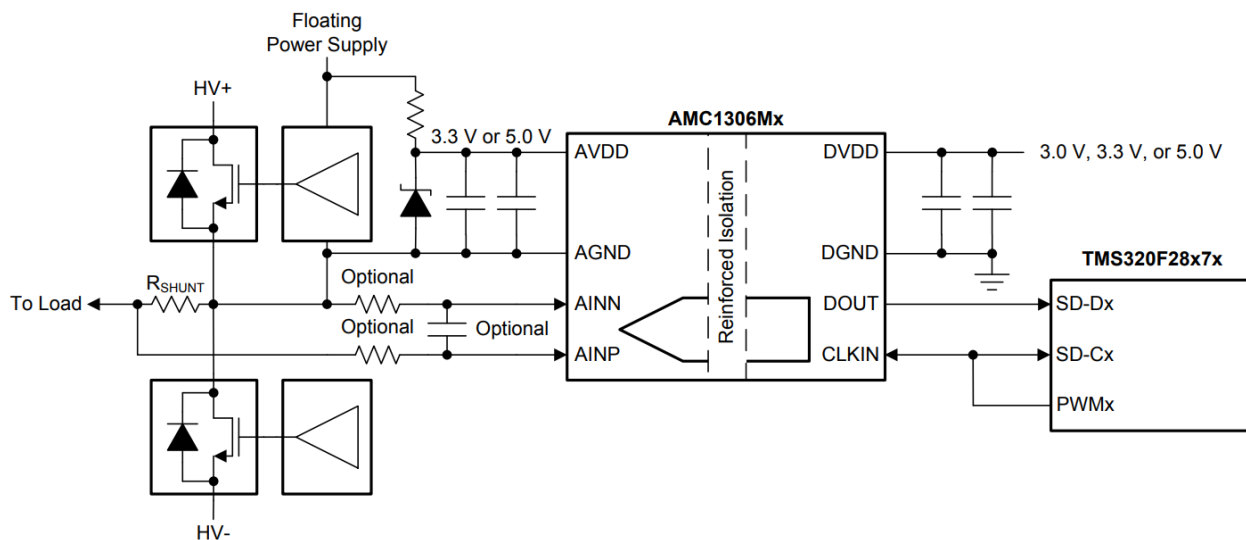
2.2.4 AMC1306M05

The AMC1306 is a precision, delta-sigma ($\Delta\Sigma$) modulator with the output separated from the input circuitry by a capacitive double isolation barrier that is highly resistant to magnetic interference. This barrier is certified to provide reinforced isolation of up to 7000 V_{PEAK} according to the DIN V VDE V 0884-11 and UL1577 standards. Used in conjunction with isolated power supplies, this isolated modulator separates parts of the system that operate on different common-mode voltage levels and protects lower-voltage parts from damage.

The input of the AMC1306 is optimized for direct connection to shunt resistors or other low voltage-level signal sources. The unique low-input voltage range of the ± 50 -mV device allows significant reduction of the power dissipation through the shunt and supports excellent ac and dc performance. The output bitstream of the AMC1306 is Manchester coded (AMC1306Ex) or uncoded (AMC1306Mx), depending on the derivate. By using an integrated digital filter (such as those in the TMS320F2807x or TMS320F2837x microcontroller families) to decimate the bitstream, the device can achieve 16 bits of resolution with a dynamic range of 85 dB at a data rate of 78 kSPS.

- Pin-compatible family optimized for shunt-resistor-based current measurements:
 - ± 50 -mV or ± 250 -mV input voltage ranges
 - CMOS or LVDS digital interface options
- Excellent DC performance supporting high-precision sensing on system level:
 - Offset error: ± 50 μ V or ± 100 μ V (max)
 - Offset drift: 1 μ V/ $^{\circ}$ C (max)
 - Gain error: $\pm 0.2\%$ (max)
 - Gain drift: ± 40 ppm/ $^{\circ}$ C (max)
- Transient Immunity: 100 kV/ μ s (typ)
- Safety-related certifications:
 - 7000-V_{PK} reinforced isolation per DIN V VDE V 0884-10 (VDE V 0884-10): 2006-12
 - 5000-V_{RMS} isolation for 1 minute per UL1577
 - CAN/CSA No. 5A-Component Acceptance Service Notice, IEC 60950-1, and IEC 60065 End Equipment Standards

Figure 5. AMC1306M05 Simplified Schematic



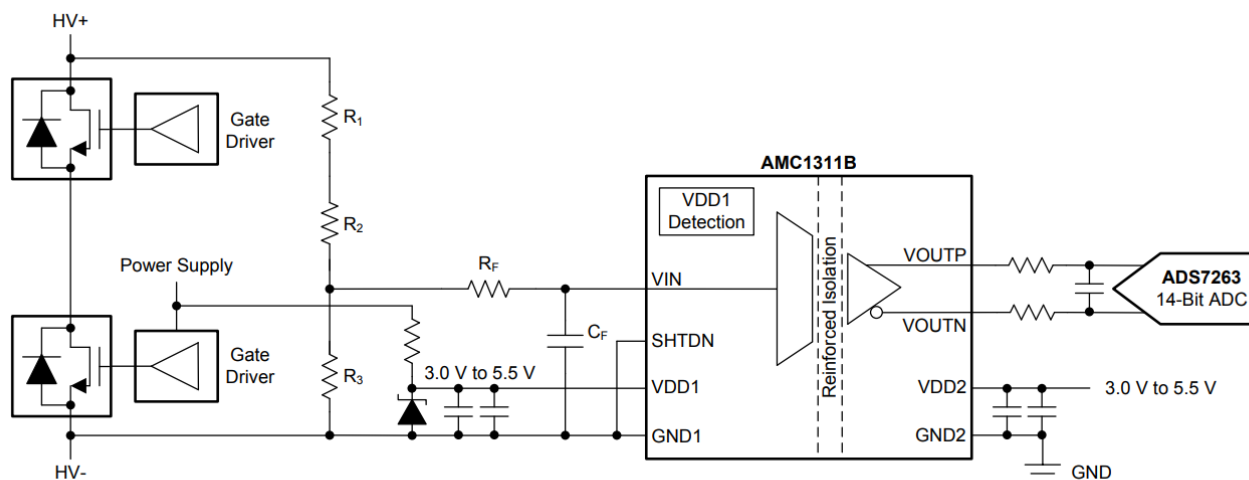
2.2.5 AMC1311

The AMC1311 is a precision, isolated amplifier with an output separated from the input circuitry by an isolation barrier that is highly resistant to magnetic interference. This barrier is certified to provide reinforced galvanic isolation of up to 7 kV_{PEAK} according to VDE V 0884-11 and UL1577. Used in conjunction with isolated power supplies, this isolated amplifier separates parts of the system that operate on different common-mode voltage levels and protects lower-voltage parts from damage.

The high-impedance input of the AMC1311 is optimized for connection to high-voltage resistive dividers or other voltage signal sources with high output resistance. The excellent performance of the device supports accurate, low temperature drift voltage or temperature sensing and control in closed-loop systems. The integrated missing high-side supply voltage detection feature simplifies system-level design and diagnostics.

- 2-V, High-Impedance Input Voltage Range Optimized for Isolated Voltage Measurement
- Low Offset Error and Drift:
 - AMC1311B: ± 1.5 mV (max), ± 15 μ V/ $^{\circ}$ C (max)
 - AMC1311: ± 9.9 mV (max), ± 20 μ V/ $^{\circ}$ C (typ)
- Fixed Gain: 1
- Very Low Gain Error and Drift:
 - AMC1311B: $\pm 0.3\%$ (max), ± 45 ppm/ $^{\circ}$ C (max)
 - AMC1311: $\pm 1\%$ (max), ± 30 ppm/ $^{\circ}$ C (typ)
- Low Nonlinearity and Drift: 0.01%, 1 ppm/ $^{\circ}$ C (typ)
- 3.3-V Operation on High-Side (AMC1311B)
- Missing High-Side Supply Indication
- Safety-Related Certifications:
 - 7000-VPK Reinforced Isolation per DIN V VDE V 0884-11 (VDE V 0884-11): 2017-01
 - 5000-VRMS Isolation for 1 Minute per UL1577
 - CAN/CSA No. 5A-Component Acceptance Service Notice, IEC 60950-1, and IEC 60065 End Equipment Standard

Figure 6. AMC1311M05 Simplified Schematic

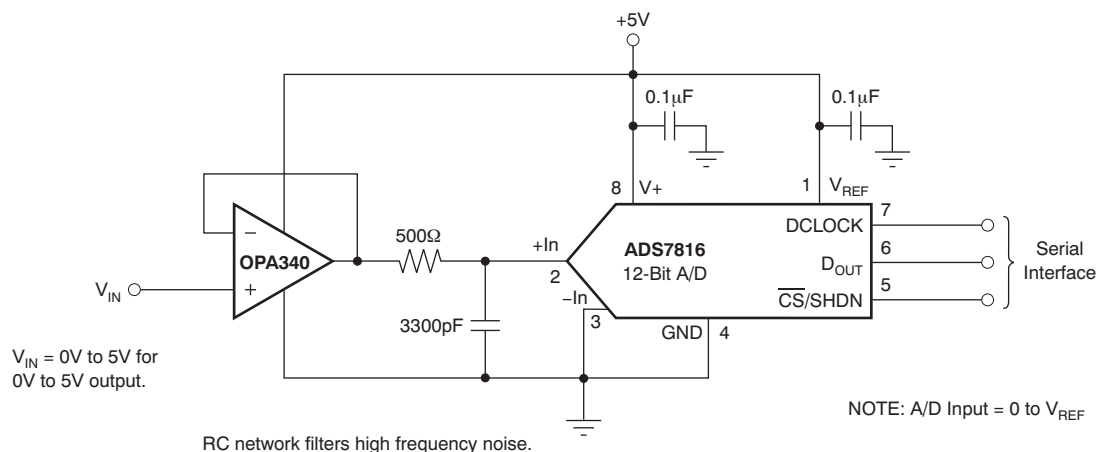


2.2.6 OPA4340

The OPA4340 series rail-to-rail CMOS operational amplifiers are optimized for low-voltage, single-supply operation. Rail-to-rail input and output and high-speed operation make them ideal for driving sampling ADCs. These op amps are also well-suited for general purpose and audio applications as well as providing I/V conversion at the output of DACs. Single, dual, and quad versions have identical specifications for design flexibility.

- Rail-to-rail input
- Rail-to-rail output (within 1 mV)
- MicroSize packages
- Wide bandwidth: 5.5 MHz
- High slew rate: 6 V/ μ s
- Low THD + noise: 0.0007% (f = 1 kHz)
- Low quiescent current: 750 μ A/channel
- Single, dual, and quad versions

Figure 7. OPA4340 in Non-Inverting Configuration

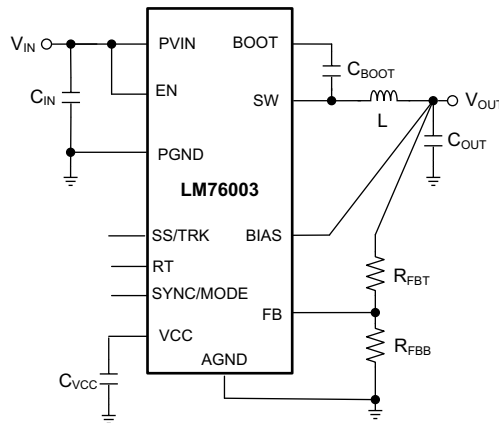


2.2.7 LM76003

The LM76002/LM76003 regulator is an easy-to-use synchronous step-down DC/DC converter capable of driving up to 2.5 A (LM76002) or 3.5 A (LM76003) of load current from an input up to 60 V. The LM76002/LM76003 provides exceptional efficiency and output accuracy in a very small solution size. Peak current-mode control is employed. Additional features such as adjustable switching frequency, synchronization, FPWM option, power-good flag, precision enable, adjustable soft start, and tracking provide both flexible and easy-to-use solutions for a wide range of applications. Automatic frequency foldback at light load and optional external bias improve efficiency. This device requires few external components and has a pinout designed for simple PCB layout with best-in-class EMI (CISPR22) and thermal performance. Protection features include thermal shutdown, input UVLO, cycle-by-cycle current limit, and short-circuit protection. The LM76002/LM76003 device is available in the WQFN 30-pin leadless package with wettable flanks.

- Integrated synchronous rectification
- Input voltage: 3.5 V to 60 V (65 V maximum)
- Output current:
 - LM76002: 2.5 A
 - LM76003: 3.5 A
- Output voltage: 1 V to 95% V_{IN}
- 15- μ A quiescent current in regulation
- Wide voltage conversion range:

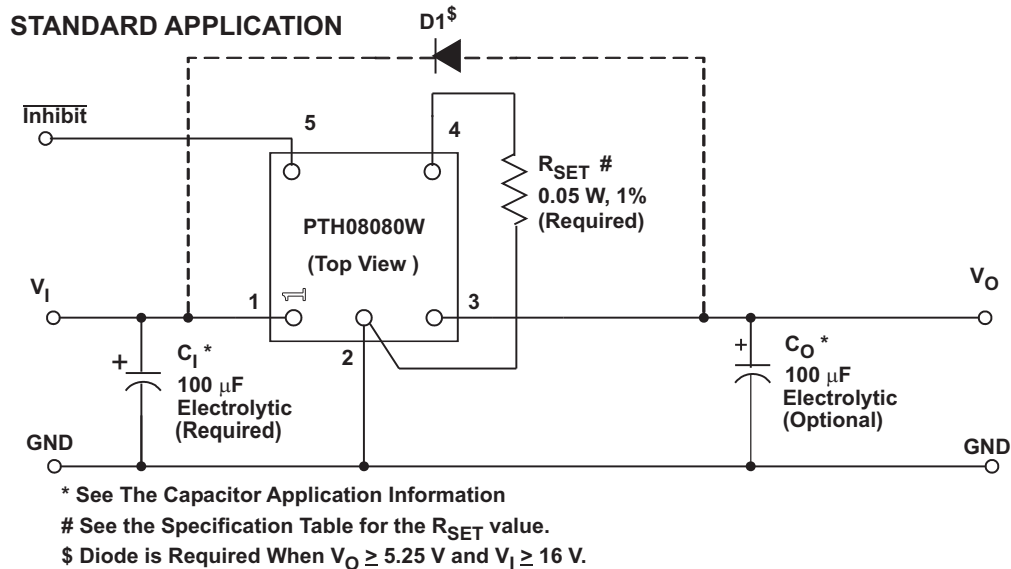
- $t_{ON-MIN} = 65$ ns (typical)
- $t_{OFF-MIN} = 95$ ns (typical)
- System-level features:
 - Synchronization to external clock
 - Power-good flag
 - Precision enable
 - Adjustable soft start (6.3 ms default)
 - Voltage tracking capability
- Pin-selectable FPWM operation
- High-efficiency at light-load architecture (PFM)
- Protection features:
 - Cycle-by-cycle current limit
 - Short-circuit protection with hiccup mode
 - Overtemperature thermal shutdown protection

Figure 8. LM76003 Simplified Schematic


2.2.8 PTH08080W

The PTH08080W is a highly integrated, low-cost switching regulator module that delivers up to 2.25 A of output current. The PTH08080W sources output current at a much higher efficiency than a TO-220 linear regulator, thereby eliminating the need for a heat sink. Its small size (0.5 × 0.6 in) and flexible operation creates value for a variety of applications.

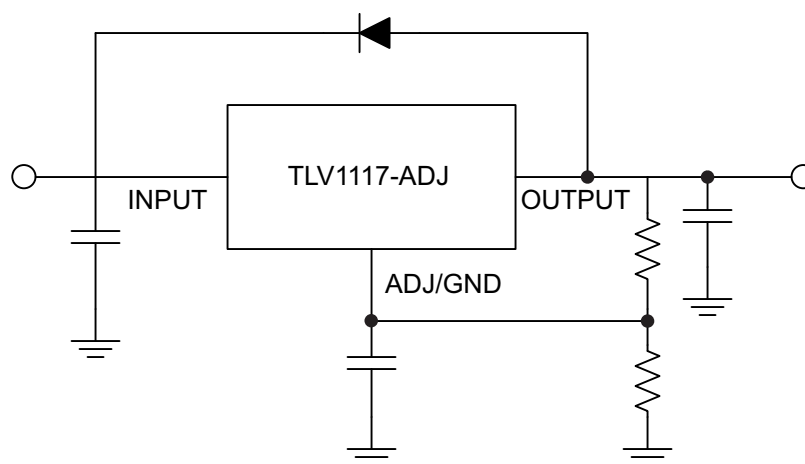
- Up to 2.25-A output current at 85°C
- 4.5-V to 18-V input voltage range
- Wide-output voltage adjust (0.9 V to 5.5 V)
- Efficiencies Up To 93%
- On/off inhibit
- UVLO
- Output overcurrent protection (non-latching, auto-reset)
- Overtemperature protection
- Ambient temperature range: –40°C to +85°C
- Surface-mount package
- Safety agency approvals: UL/CUL 60950, EN60950

Figure 9. PTH08080W Standard Application


2.2.9 TLV1117

The TLV1117 device is a positive low-dropout voltage regulator designed to provide up to 800 mA of output current. The device is available in 1.5-V, 1.8-V, 2.5-V, 3.3-V, 5-V, and adjustable-output voltage options. All internal circuitry is designed to operate down to 1-V input-to-output differential. Dropout voltage is specified at a maximum of 1.3 V at 800 mA, decreasing at lower load currents.

- 1.5-V, 1.8-V, 2.5-V, 3.3-V, 5-V, and adjustable-output voltage options
- Output current: 800 mA
- Specified dropout voltage at multiple current levels
- 0.2% line regulation maximum
- 0.4% load regulation maximum

Figure 10. TLV1117 Simplified Schematic


2.2.10 OPA350

The OPA350 series of rail-to-rail CMOS operational amplifiers are optimized for low-voltage, single-supply operation. Rail-to-rail input and output, low-noise ($5 \text{ nV}/\sqrt{\text{Hz}}$), and high-speed operation (38 MHz, $22 \text{ V}/\mu\text{s}$) make the amplifiers ideal for driving sampling ADCs. They are also suited for cell phone PA control loops and video processing ($75\text{-}\Omega$ drive capability), as well as audio and general purpose applications. Single, dual, and quad versions have identical specifications for maximum design flexibility.

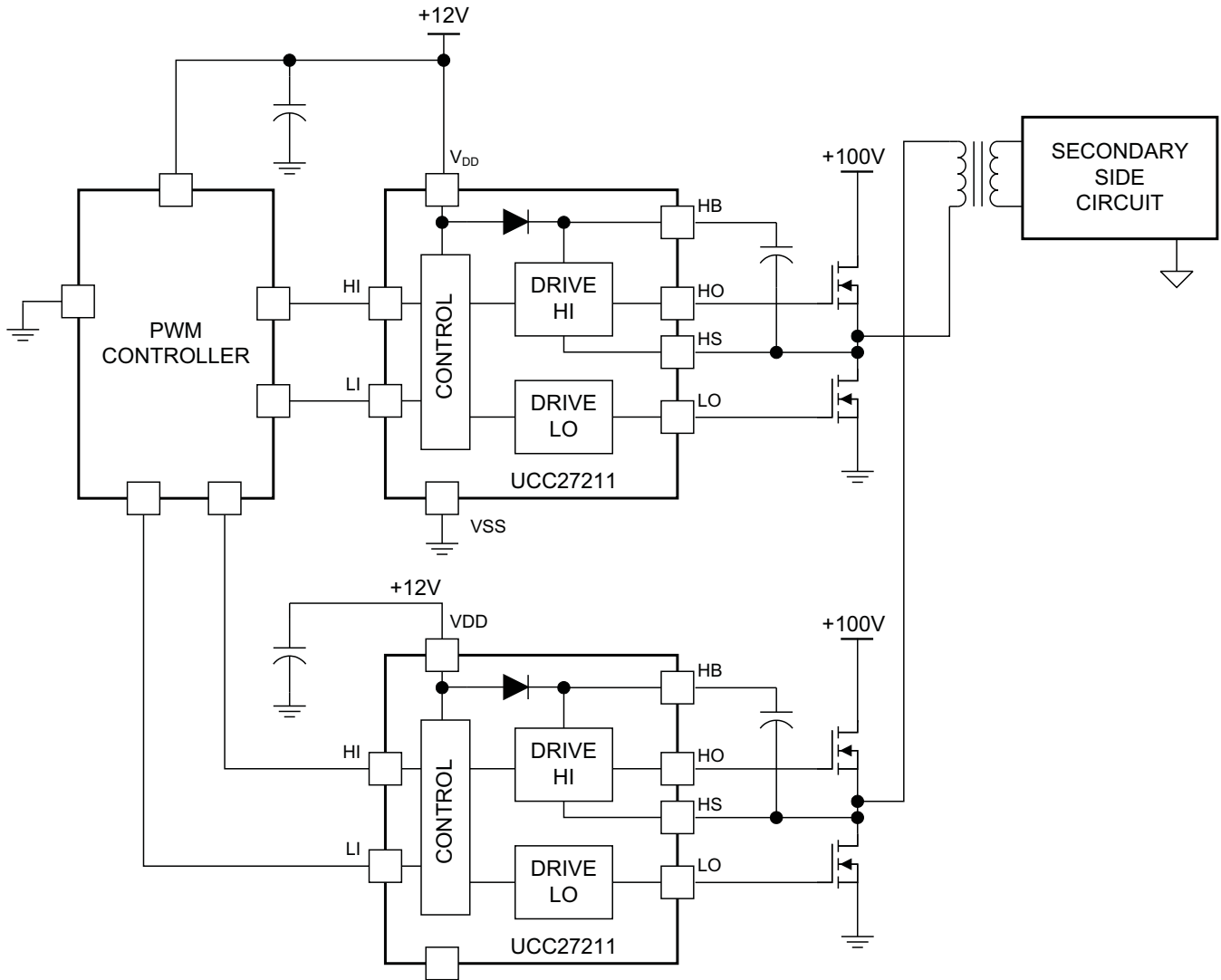
- Rail-to-rail input
- Rail-to-rail output (within 10 mV)
- Wide bandwidth: 38 MHz
- High slew rate: $22 \text{ V}/\mu\text{s}$
- Low noise: $5 \text{ nV}/\sqrt{\text{Hz}}$
- Low THD+noise: 0.0006%
- Unity-gain stable
- MicroSize packages
- Single, dual, and quad

2.2.11 UCC27211

The UCC27210 and UCC27211 drivers are based on the popular UCC27200 and UCC27201 MOSFET drivers, but offer several significant performance improvements. Peak output pullup and pulldown current has been increased to 4-A source and 4-A sink, and pullup and pulldown resistance have been reduced to 0.9Ω , thereby allowing for driving large power MOSFETs with minimized switching losses during the transition through the Miller Plateau of the MOSFET. The input structure is now able to directly handle -10 VDC , which increases robustness and also allows direct interface to gate-drive transformers without using rectification diodes. The inputs are also independent of supply voltage and have a maximum rating of 20-V.

- Drives two N-channel MOSFETs in high-side and low-side configuration with independent inputs
- Maximum boot voltage: 120-V DC
- 4-A sink, 4-A source output currents
- $0.9\text{-}\Omega$ pullup and pulldown resistance
- Input pins can tolerate -10 V to $+20 \text{ V}$ and are independent of supply voltage range
- TTL or pseudo-CMOS compatible input versions
- 8-V to 17-V VDD operating range (20-V absolute maximum)
- 7.2-ns rise and 5.5-ns fall time with 1000-pF load
- Fast propagation delay times (18 ns typical)
- 2-ns delay matching
- Symmetrical UVLO for high-side and low-side driver
- All industry standard packages available (SOIC-8, PowerPAD™ SOIC-8, 4-mm × 4-mm SON-8 and 4-mm × 4-mm SON-10)
- Specified from -40°C to $+140^\circ\text{C}$

Figure 11. UCC27211 Typical Application



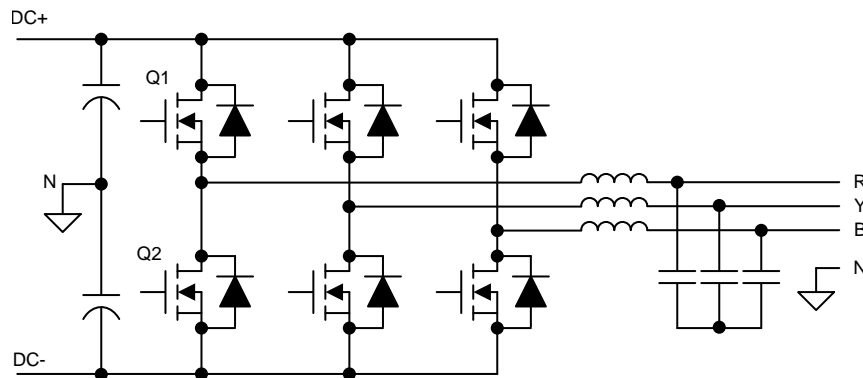
2.3 System Design Theory

2.3.1 Three-Phase T-Type Converter

2.3.1.1 Architecture Overview

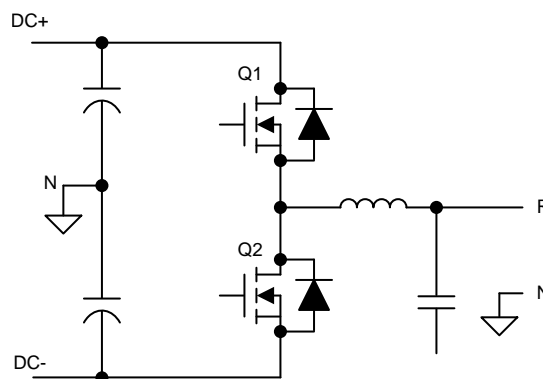
To understand the impetus behind a three level t-type converter, some background on a traditional two-level converter is required. Figure 12 shows a typical implementation of this architecture.

Figure 12. Two-Level, Three-Phase Converter Architecture



To simplify the analysis, a single leg can be isolated.

Figure 13. Two-Level, Single-Phase Converter Leg



In this example, the two switching devices as a pair have four possible conduction states, independent of the other phases:

Figure 14. Q1 and Q2 off

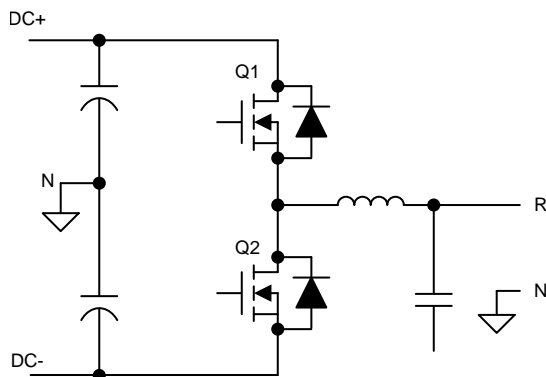
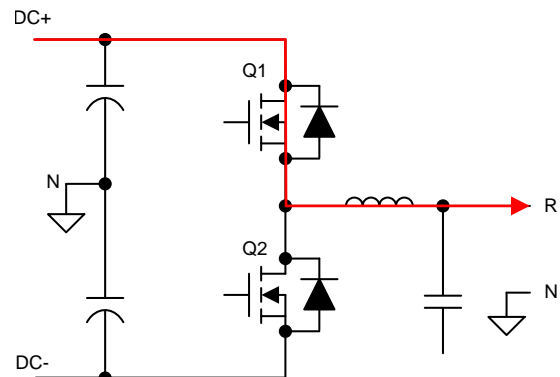
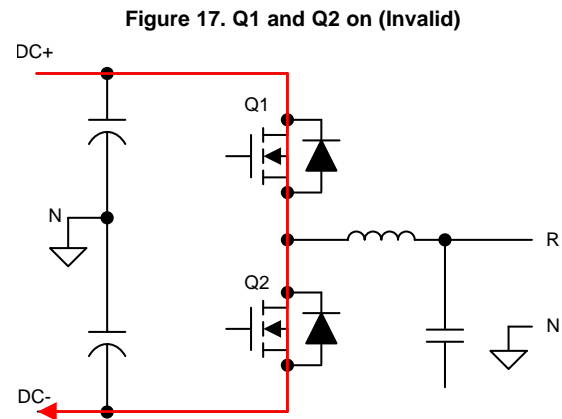
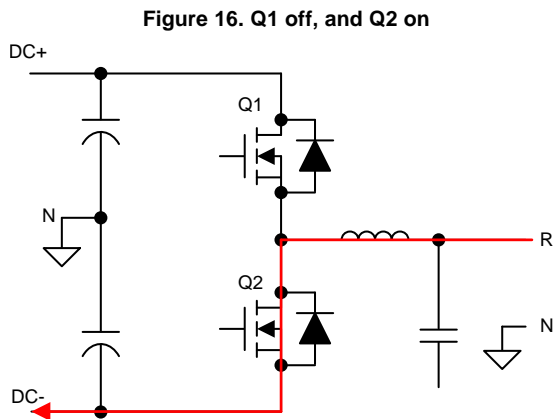


Figure 15. Q1 on, and Q2 off





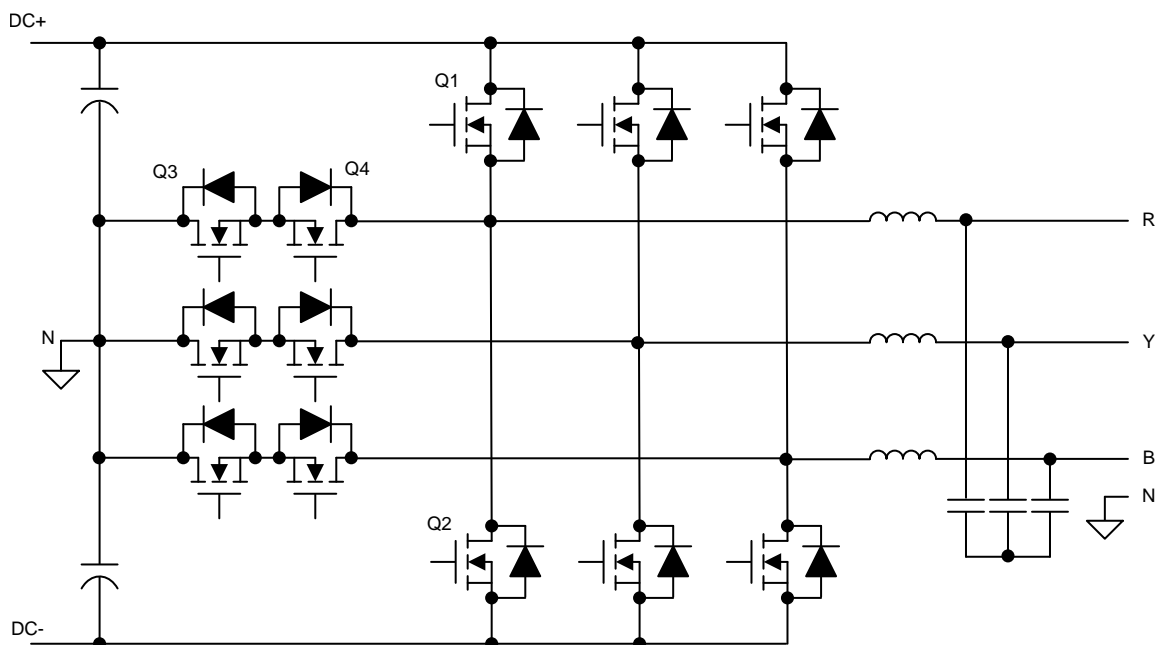
By observing the current path through the power stage, each switching device must be capable of blocking the full DC link voltage present between DC+ and DC-. In traditional low-voltage systems (< 600 V), this capability is fairly trivial with common off-the-shelf IGBTs. However, if the DC link voltage is pushed higher to increase the power throughput without increasing current, as is a common trend in power electronics, this limitation puts an upper level on the supported voltage ranges.

Additionally, the increased voltage does result in increased switching losses in the traditional IGBTs. The low dV/dt exacerbates itself in these devices, even if they are able to support the higher voltages. This dV/dt is what determines how quickly one device can transition from on to off (or vice versa), thus dictating the dead time between each of these states. An elongated switch time or dead time means the switches spend less time at full conduction, resulting in decreased efficiency.

These two primary drawbacks of a two-level converter are what drives the implementation in this design.

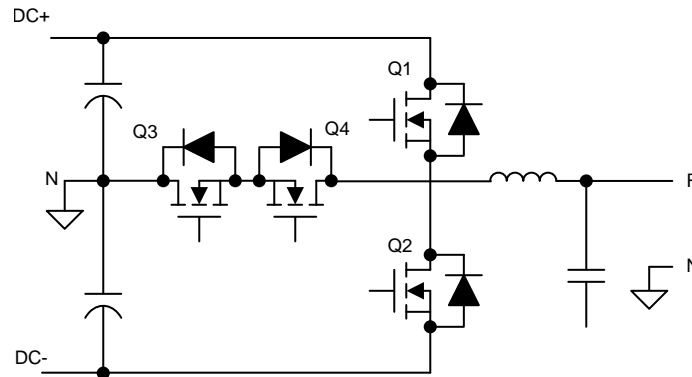
The next step up from a standard two-level converter is a T-type three-level converter. This type is implemented by inserting two back-to-back switching devices between the switch node and the neutral point of the DC link created by the bulk input capacitors. These two switch devices are placed in a common emitter configuration so that current flow can be controlled by switching one or the other on or off. This configuration also enables both of them to share a common bias supply as the gate-emitter voltage is identically referenced. Figure 18 shows a simplified view of the implementation.

Figure 18. Three-Level T-Type, Three-Phase Converter Architecture



To assist in understanding the benefits of the architecture, the converter is again reduced to a single leg.

Figure 19. Three-Level T-Type, Single-Phase Converter Leg



Adding two extra switching devices complicates the control of the system, but the same process of evaluating current flow during various modulation points illustrates the architecture benefits. Additionally, a simplified commutation scheme can be demonstrated, illustrating that control of a T-type converter is not substantially more difficult than a traditional two-level architecture.

A single leg has three potential connection states: DC+, DC-, or N. This connection can be accomplished by closing Q1, closing Q3 and Q4, and closing Q2, respectively. However, this scheme depends on the current path in the system. Rather, for a DC+ connection, Q1 and Q3 can be closed, Q2 and Q4 for a neutral connection, and Q2 and Q4 for a DC- connection. This scheme acts independent of current direction as the following figures show.

Figure 20. Q1 on, Q2 off, Q3 on, and Q4 off

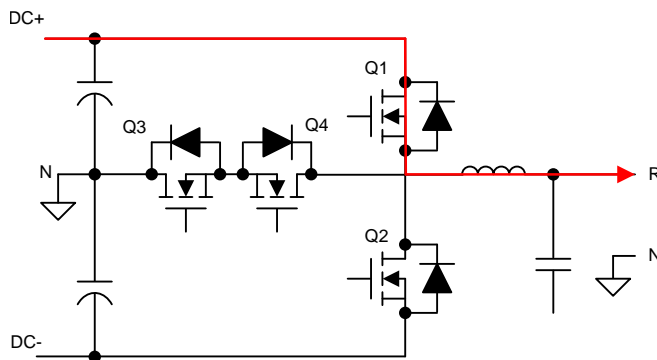


Figure 21. Q1 off, Q2 off, Q3 on, and Q4 off

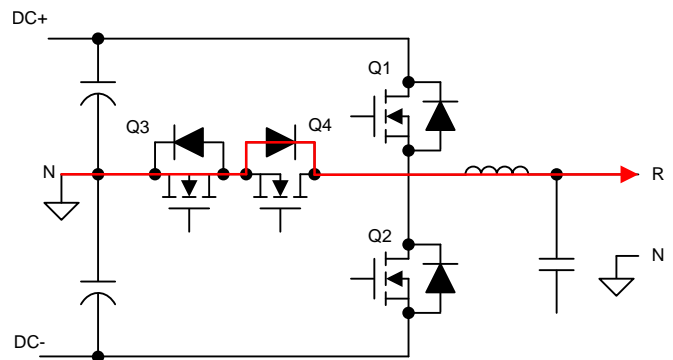
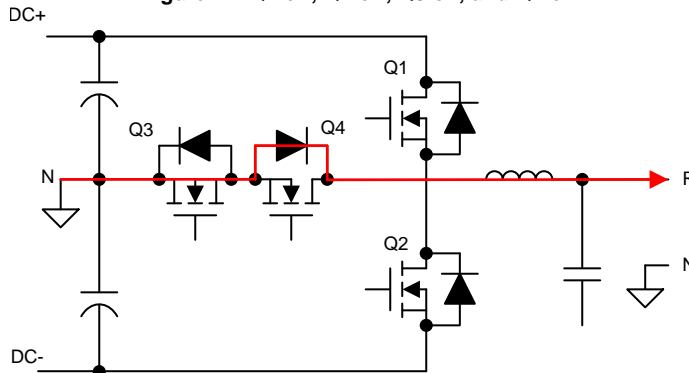


Figure 22. Q1 off, Q2 off, Q3 on, and Q4 on



This example starts with the input phase connected to DC+ by closing Q1 and Q3, resulting in current output from the system. To transition to an N connection, Q1 is opened and after a dead-time delay, Q4 is closed. This setup allows current to naturally flow through Q3 and the diode of Q4.

Figure 23. Q1 on, Q2 off, Q3 on, and Q4 off

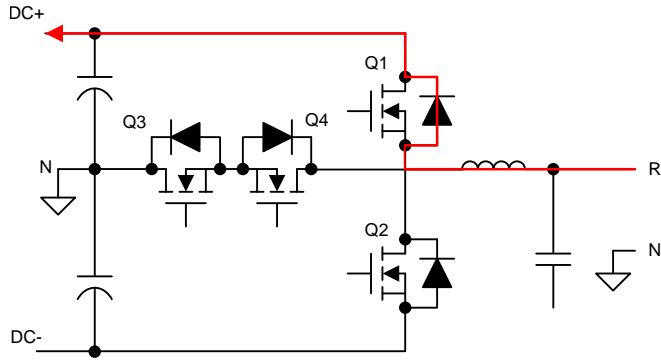


Figure 24. Q1 off, Q2 off, Q3 on, and Q4 off

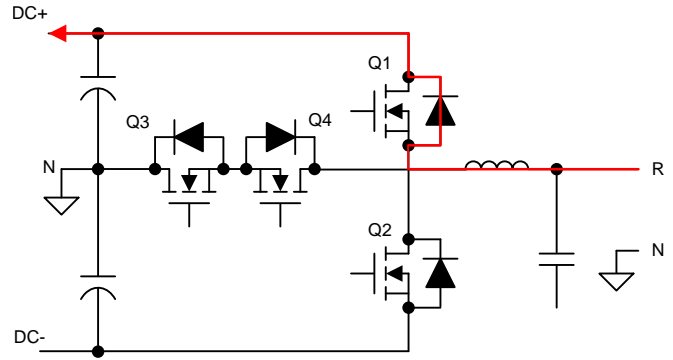
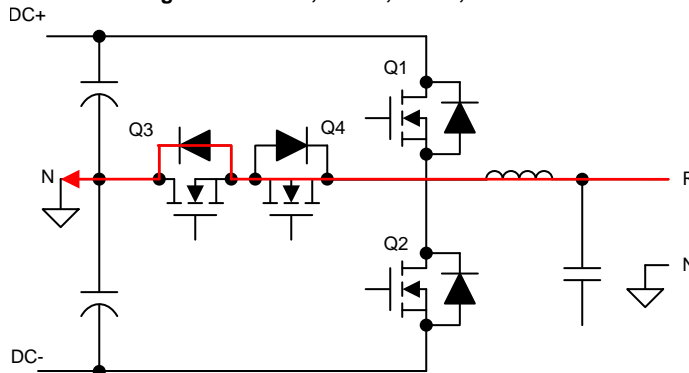


Figure 25. Q1 off, Q2 off, Q3 on, and Q4 on



For a negative current, the same sequence can be used. Once Q4 is closed, current then flows through it and the diode of Q3 rather than the diode of Q1.

Figure 26. Q1 off, Q2 off, Q3 on, Q4 on

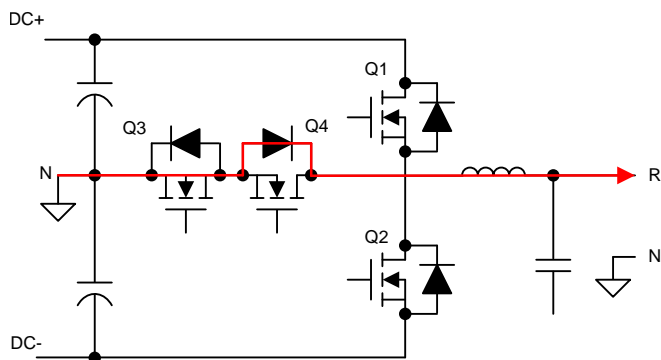
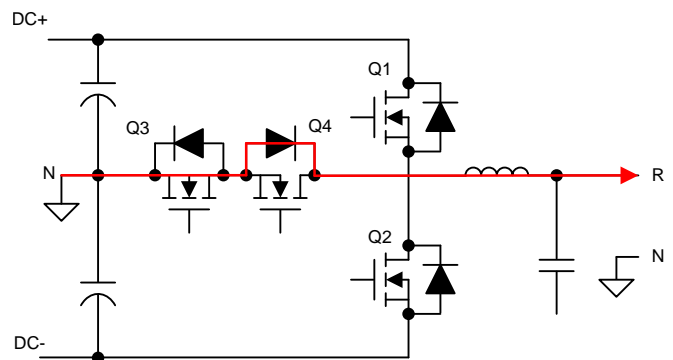
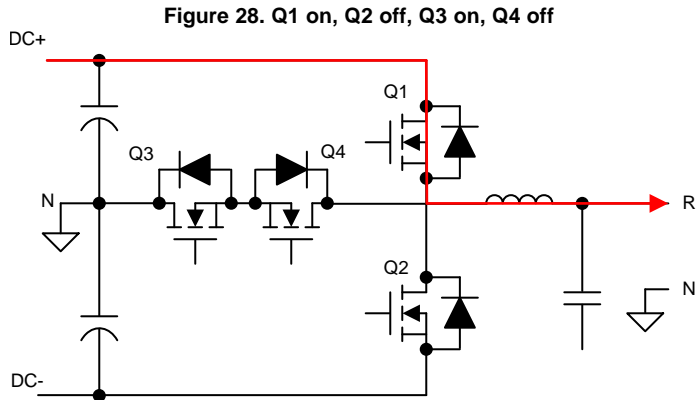
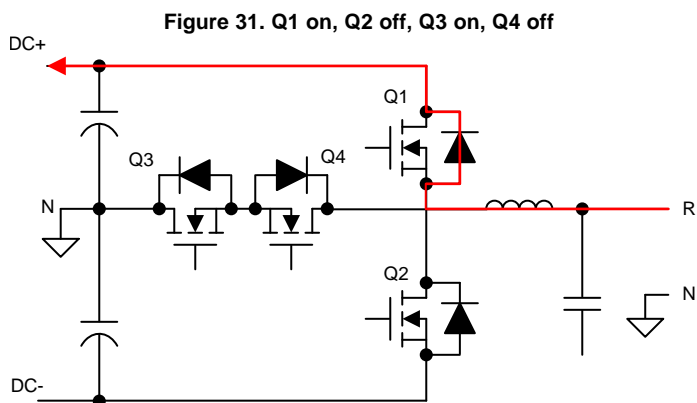
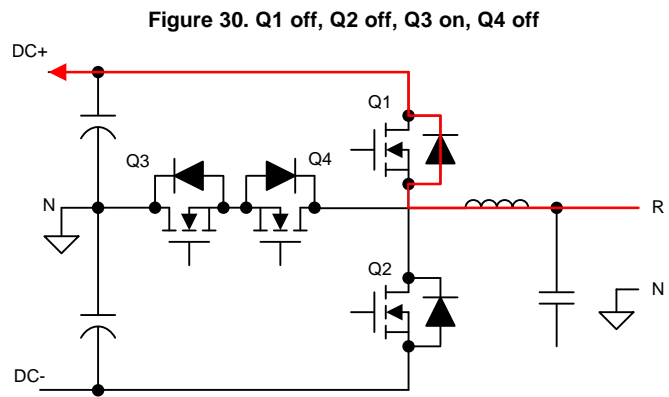
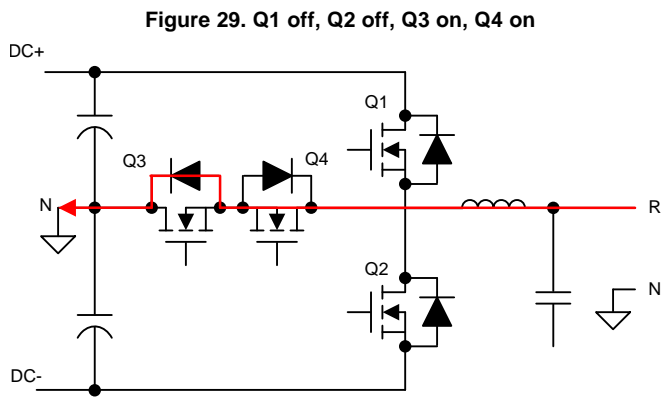


Figure 27. Q1 off, Q2 off, Q3 on, Q4 off





A similar natural current flow can be observed when connecting the output leg from N to DC+ with a positive current. Q3 and Q4 start closed with a full N connection. Q4 is switched off, but current still flows through its associated diode. Closing Q1 now naturally switches the current flow from N to DC+.



As in the earlier example when moving from a DC+ to N connection on a negative current, the same scheme can also be used here for a positive current. Q3 and Q4 begin closed, conducting current into N. Q4 is opened, causing current to flow through the diode of Q1. Lastly, Q1 is closed, and current remains flowing in the same direction.

All four of these transition states (DC+ to N, N to DC+, with both forward and reverse current) all share two simple switching schemes. This also holds true for transitions to and from DC- through Q2. By maintaining this scheme through all switching cycles, a simple dead-zone delay between switching events is all that is needed to avoid shoot-through; however, additional protection can be added in the control software with relative ease.

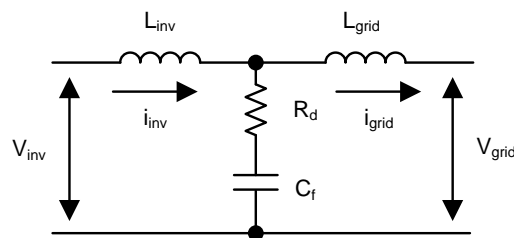
An additional benefit from this modulation scheme is that Q3 and Q4 never switch at the same time. This benefit reduces voltage stress on the devices as well as the power rating of the bias supply to drive these devices effectively. As mentioned earlier, Q3 and Q4 can share a single supply sized for one driver rather than two.

Q1 and Q2 still need to block the full DC link voltage as they would in the traditional architecture. To use a higher DC bus voltage, full-voltage FETs still need to be in place here; however, because they are back to back and do not switch at the same time, the two switches on the center leg can be at a lower rating.

2.3.1.2 LCL Filter Design

Any system of power transfer with the grid is required to meet certain output specifications for harmonic content. In many rectifiers, a high-order LCL filter typically provides sufficient harmonic attenuation, along with reducing the overall design size versus a simpler filter design. However, due to the higher order nature, take some care in its design to control resonance. Figure 32 shows a typical LCL filter.

Figure 32. LCL Filter Architecture



One of the key benefits of using SiC MOSFETs (as this reference design does) is the ability to increase the switching frequency of the power stage significantly versus traditional Si-based switching elements. This increased switching frequency has a direct impact on the filter resonant design of the converter, which needs to be accounted for. To ensure that the filter is designed correctly around this switch frequency, this known mathematical model is used in this design.

The primary component is the switch side inductor, or L_{inv} , which can be derived using Equation 1:

$$L_{inv} = \frac{V_{DC}}{8 \times f_{SW} \times I_{grid_rated} \times \%ripple} \tag{1}$$

Using re-determined system specifications, one can easily calculate the primary inductor value:

$$L_{inv} = \frac{1000 \text{ V}}{8 \times 50 \text{ kHz} \times 18 \text{ A} \times 40\%} = 347 \mu\text{H} \tag{2}$$

The sizing of the primary filter capacitor is handled in a similar fashion using Equation 3:

$$C_f = \frac{\%x \times Q_{rated}}{2 \times \pi \times F_{grid} \times V_{grid}^2} \tag{3}$$

Make some design assumptions to finalize the value of C_f , namely, limiting the total reactive power absorbed by the capacitor to 5%. Scaling the total system power by the per phase power results in a primary capacitor value of:

$$C_f = \frac{5\% \times \frac{10 \text{ kW}}{3}}{2 \times \pi \times 50 \text{ Hz} \times \left(\frac{400}{\sqrt{3}}\right)^2} = 9.947 \mu\text{F} \tag{4}$$

For the remainder of the filter design, determine the values by defining the attenuation factor between the allowable ripple in grid inductor and the switching inductor. This factor needs to be minimized while still maintaining a stable and cost effective total filter. By assuming an attenuation factor, an r value, which defines the ratio between the two inductors, is determined using Equation 5:

$$I_{att} = \frac{1}{\left|1 + r \times \left(1 - L_{inv} \times C_f \times (2 \times \pi \times f_{SW})^2 \times x\right)\right|} \times 100 \tag{5}$$

To obtain an attenuation factor of 10%, and using the earlier derived values, the value of r can be evaluated by rewriting this to be:

$$r = \left| \frac{\frac{1}{10\%} - 1}{1 - 347 \mu\text{H} \times 9.95 \mu\text{F} \times (2 \times \pi \times 50 \text{ kHz})^2 \times 5\%} \right| = 2.7\% \quad (6)$$

The resultant value for L_{grid} is then:

$$L_{\text{grid}} = r \times L_{\text{inv}} = 9.34 \mu\text{H} \quad (7)$$

The filter design can be validated by determining its resonant frequency (F_{res}). A good criteria for ensuring a stable F_{res} is that it is an order of magnitude above the line frequency and less than half the switching frequency. This criteria avoids issues in the upper and lower harmonic spectrums. The resonant frequency of the filter is defined using Equation 8:

$$F_{\text{res}} = \frac{1}{\sqrt{\frac{L_{\text{grid}} \times L_{\text{inv}}}{L_{\text{grid}} + L_{\text{inv}}} \times C_f}} \times 2 \times \pi \quad (8)$$

Or, using the derived filter values:

$$F_{\text{res}} = \frac{1}{\sqrt{\frac{9.34 \mu\text{H} \times 347 \mu\text{H}}{9.34 \mu\text{H} + 347 \mu\text{H}} \times 9.95 \mu\text{F}}} \times 2 \times \pi = 16.733 \text{ kHz} \quad (9)$$

This value for F_{res} meets the criteria listed earlier and validates the filter design.

The remaining value to determine is the passive damping that must be added to avoid oscillation. Generally, a damping resistor at the same relative order of magnitude as the C_f impedance at resonance is suitable. This impedance is easily derived using Equation 10:

$$R_d = \frac{1}{6 \times \pi \times F_{\text{res}} \times C_f} \quad (10)$$

$$R_d = \frac{1}{6 \times \pi \times 16.733 \text{ kHz} \times 9.95 \mu\text{H}} = 0.316 \Omega \quad (11)$$

For the final implementation in hardware, use real values for all of these components based on product availability and must be chosen to be appropriately close ($\pm 10\%$ typically). When final values are determined, recalculate the resonant frequency to ensure the filter is still stable.

2.3.1.3 Inductor Design

With the filter being one of the major contributors to the size and weight of a power stage, ensure that the individual components are correctly sized. As seen in Section 2.3.1.2, the increase in the system switching speed provided by the SiC MOSFETs has already resulted in a power stage inductor that is of much smaller value than normal.

In Equation 1, the switching frequency is in the denominator. Any increase in switch frequency, all else being the same, results in an inverse relationship. Looking at the simplified equation for the inductance of a given inductor, there is a positive relationship between inductance and inductor cross sectional area by a number of turns. Both have a direct effect on the size of the component.

$$L = \frac{0.4 \times \pi \times \mu \times N^2 \times A \times 10^{-2}}{\ell}$$

where

- μ is core permeability
 - N is the number of turns
 - A is the cross sectional area
 - ℓ is the mean magnetic path length
- (12)

The starting point for evaluating a solution to the variables in Equation 12 is to determine a valid core material and subsequent permeability. The core manufacturer typically has a range of suitable materials with selection criteria based on the design inductance and the inductor current. For this design, the nominal inductor current (with an overload factor of 105%) is defined as:

$$I_{\text{ind_nom}} = \frac{\text{KVA}_{\text{out}} \times 105\%}{\sqrt{3} V_{\text{grid}}} \quad (13)$$

$$I_{\text{ind_nom}} = \frac{10 \text{ kVA} \times 105\%}{\sqrt{3} \times 400} = 15.155 \text{ A} \quad (14)$$

Using a selection guide for a toroidal inductor core manufacturer, at 347 μH , the core permeability comes to 26 μ . The core also provides a value for the inductance factor, A_L , which enables a quick path to selecting the number of turns.

$$N = \sqrt{\frac{L \times 10^3}{A_L}} \quad (15)$$

$$N = \sqrt{\frac{347 \mu\text{H} \times 10^3}{49}} = 84 \quad (16)$$

One last piece of information required for the inductor design is the winding wire size. This size is easily computed using the nominal inductor current rating. Using copper, with a current carrying density of 4 A/mm², this inductor requires a cross sectional area of:

$$A_w = \frac{I_{\text{ind_nom}}}{4} = \frac{15.155}{4} = 3.789 \text{ mm}^2 \quad (17)$$

This area is an equivalent to American Wire Gauge #12, which has a cross sectional area of 3.309 mm². This slight derating is acceptable because the switching current allows a smaller gauge to be used when compared to a static DC bias current. For this inductor, flat winding is used to increase surface area for cooling and decrease potential skin depth effects.

Using the overall design of the core, with the flat 12 AWG winding, the total length of each winding is determined to be 64.87 mm. At this point, the DC resistance of the inductor can be calculated using Pouillet's Law:

$$R_{\text{DC}} = \rho \frac{l}{A} \quad (18)$$

$$R_{\text{DC}} = \left(17 \times 10^{-9}\right) \frac{84 \times 64.87 \text{ mm} \times 10^{-3}}{3.309 \text{ mm}^2 \times 10^{-6}} = 0.028 \Omega \quad (19)$$

To determine the AC resistance, first calculate the skin depth at the power stage switching frequency:

$$S_d = 1000 \times \sqrt{\frac{\rho}{\pi \times f_{\text{SW}} \times \mu_o}} \quad (20)$$

$$S_d = 1000 \times \sqrt{\frac{17 \times 10^{-9}}{\pi \times 50 \text{ kHz} \times 4 \times \pi \times 10^{-7}}} = 0.293 \text{ mm} \quad (21)$$

R_{AC} is then determined by R_{DC} , S_d , and S_s , which is the equivalent square conductor width.

$$R_{\text{AC}} = R_{\text{DC}} \times \frac{1}{2} \times \left(\frac{S_s}{S_d}\right) \times \left(\frac{\sinh\left(\frac{S_s}{S_d}\right) + \sin\left(\frac{S_s}{S_d}\right)}{\cosh\left(\frac{S_s}{S_d}\right) - \cos\left(\frac{S_s}{S_d}\right)}\right) = 0.087 \Omega \quad (22)$$

This determination of R_{AC} helps determine total system losses.

2.3.1.4 SiC MOSFET and IGBT Selection

As shown in the architecture overview, the main switching device needs to support the full switching voltage. To support the 1000-V DC link voltage of this design, use 1200-V FETs; however, at this voltage, the migration to SiC is necessitated by several factors:

- The switching speed of a 1200-V SiC MOSFET is significantly faster than a traditional IGBT, leading to a reduction in switching losses.

- The reverse recovery charge is significantly smaller in the SiC MOSFET, resulting in reduced voltage and current overshoot.
- A lower temperature dependence at due to reduced conduction loss increase at full load.

The middle switches are only exposed to half of the DC link voltage, or 500 V in this design. As such, a 650-V device is suitable. A full SiC solution provides the best performance due to these same features; however, the cost would be higher. To reduce overall system cost, traditional Si switching devices can be used. A few factors dictate the choice of device:

- Si MOSFETs have a resistive feature that helps to reduce conduction loss at light load conditions compared with IGBT, but the high reverse recovery of the body diode increases voltage and current overshoot. Because SiC MOSFETs switch much faster than Si devices, the reverse recovery is much more severe.
- Si IGBTs have higher conduction loss at light load, but the reverse recovery can be lower if a fast recovery diode is used as the antiparallel diode. Moreover, because an IGBT is a unidirectional device, the current always conducts through one anti-parallel diode in T-type topology. The light load efficiency will be reduced.

For this design, the reverse recovery loss and voltage overshoot limits the device selection. As such, a 1200-V SiC MOSFET + 650-V IGBT solution is used.

Conduction loss is mainly determined by the $R_{DS(on)}$ of the 1200-V SiC MOSFET and the on voltage drop of the 650-V IGBT. The 80-m Ω SiC devices have a good high-temperature performance, and the $R_{DS(on)}$ only increases 30% at 150°C junction temperature. With the high temperature I-V curve in the data sheet, calculate the conduction loss on the devices.

Switching loss is a function of the switching frequency and switching energy of each switching transient, the switching energy is related with device current and voltage at the switching transient. Using the switching energy curve in the data sheet, one can estimate the total switching loss. Note that the switching energy curve in the data sheet is measured with SiC diode freewheeling, but in a T-type converter, the freewheeling device is the Si diode in IGBT. The switching loss is expected to be higher than calculated result.

Similarly, the conduction loss and switching loss can be estimated for all the devices and efficiency can be estimated. With the thermal impedance information of the thermal system design, the proper device rating can be selected. The 1200-V/80-m Ω SiC MOSFET and 650-V/30-A IGBT is a good tradeoff among thermal, efficiency and cost.

2.3.1.5 Loss Estimations

The primary source of lost efficiency in any converter is going to be a result of the losses incurred in the switching devices. These losses are broken into three categories for each device:

- Conduction loss: When the device is on and conducting normally
- Switching loss: When the device is switching between states
- Diode conduction loss: Related to voltage drop and current when in conduction

Each of these are dictated by their own equation, and can be determined from the device data sheet and design parameters that have already been set.

Conduction loss is driven by the on-time of the FET, the switched current, and the on-resistance:

$$P_{cond_loss} = \frac{1}{T} \int_0^T V_{ce}(t) \times I_c(t) \times D_Q(t) dt$$

where

- V_{ce} is the conduction voltage drop
- I_c is the conduction current
- D_Q is the duty cycle
- T represents one modulation cycle

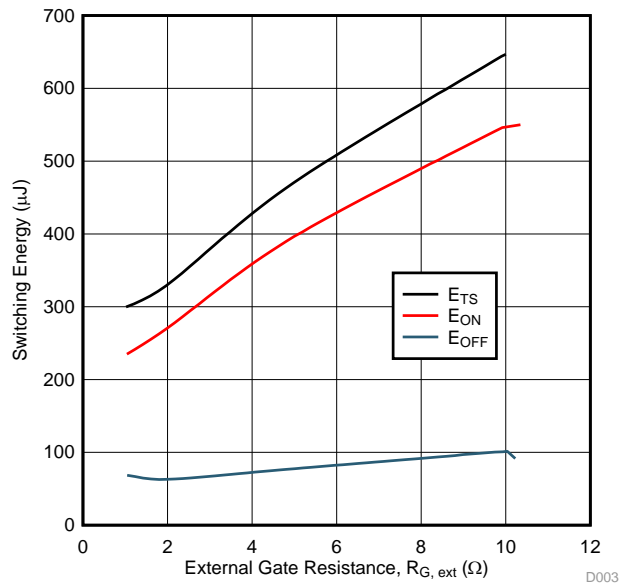
(23)

Switching loss is determined by the switching energy of the device and the switching voltage at a selected test point. Determine the value of the switching energy from the device data sheet using the value of the designed external gate resistor. The remainder of the values needed were determined earlier in the design phase.

$$P_{sw_loss} = \frac{(E_{on} + E_{off}) \times I_{peak} \times f_{sw} \times V_{DC}}{\pi \times I_{avg} \times V_{nom}} \tag{24}$$

Figure 33 shows an example of the graph used to extract the switching energy values from the device data sheet is shown for an LSIC1MO120E0080 SiC MOSFET. Note that at this time the switching energies of this SiC MOSFET are an order of magnitude lower than those of the IGBTs used in the system. Even at this stage, it is easy to see how the higher electron mobility in SiC results in reduced switch loss.

Figure 33. Switching Energy vs Gate Resistance for LSIC1MO120E0080



The diode conduction loss is similarly calculated using known values:

$$P_{sw_diode} = \frac{1}{T} \int_0^T V_f(t) \times I_f(t) \times D_d(t) dt$$

where

- V_f is the voltage drop
- I_f is the diode current
- D_d is the duty cycle
- T represents one modulation cycle

(25)

Using these three equations, the expected losses of the design are computed for both the SiC MOSFETs and IGBTs as Table 2 shows.

Table 2. Expected Losses of Switching Devices

PARAMETER	LSIC1MO120E0080 (Q1)	IKW20N60TFKSA1 (Q3)
Conduction loss	4.095 W	2.08 W
Switching loss	1.536 W	2.789 W
Diode loss	0 W	2.697 W
Total	5.631 W	7.566 W

The final piece of the total system loss estimation is the inductor losses. These losses are determined using the value of the inductor DC and AC resistance and expected inductor current from Section 2.3.1.3.

$$P_{ind_loss} = I_{ind_ac_rms}^2 \times R_{DC} + I_{ind_ripple_rms}^2 \times R_{AC} \tag{26}$$

$$P_{ind_loss} = (0.81 A)^2 \times 0.024 \Omega + (15.155)^2 \times 0.076 \Omega = 5.64 W \tag{27}$$

The total major energy loss for this design is then:

$$P_{\text{loss_total}} = 6 \times (P_{Q1_total} + P_{Q3_total}) + 3 \times P_{\text{int_loss}} \quad (28)$$

$$P_{\text{loss_total}} = 6 \times (5.631 \text{ W} + 7.56 \text{ W}) + 3 \times 5.64 \text{ W} = 96.102 \text{ W} \quad (29)$$

Equation 29 can then be used to determine the total expected converter efficiency. Note that this is an estimation, but it will allow the design to be validated up to this point.

$$\eta = \frac{P_{\text{out}}}{P_{\text{out}} + P_{\text{loss_total}}} \times 100 \quad (30)$$

$$\eta = \frac{10 \text{ kW}}{10 \text{ kW} + 96.102 \text{ W}} = 99.048\% \quad (31)$$

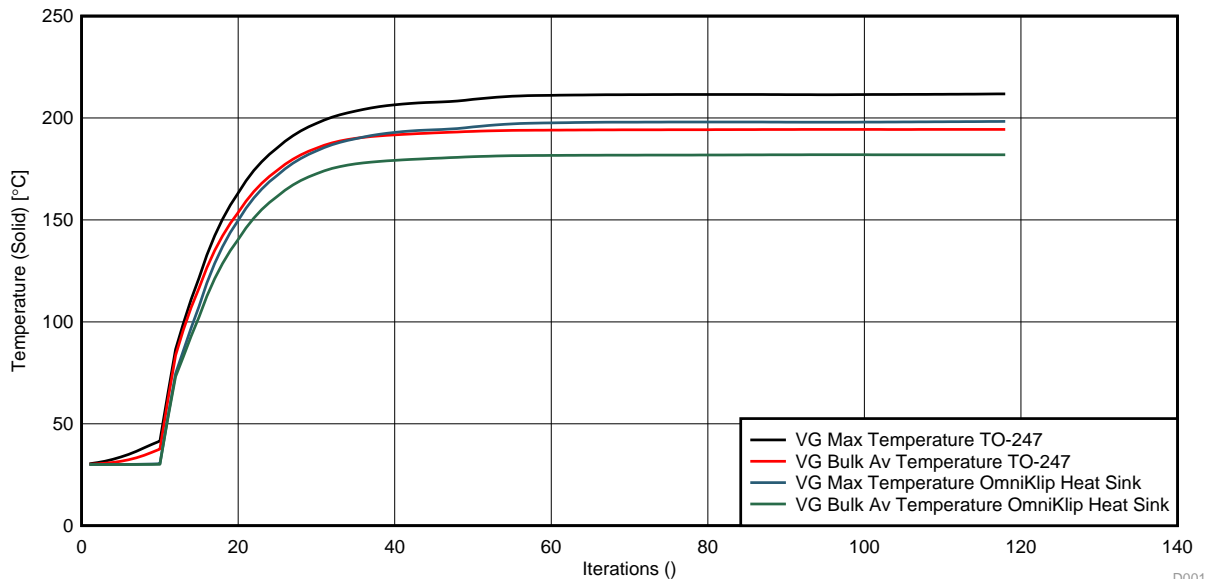
2.3.1.6 Thermal Considerations

The loss estimations can also allow the heat output of the design to be characterized. Any electrical loss in the system is converted to waste heat.

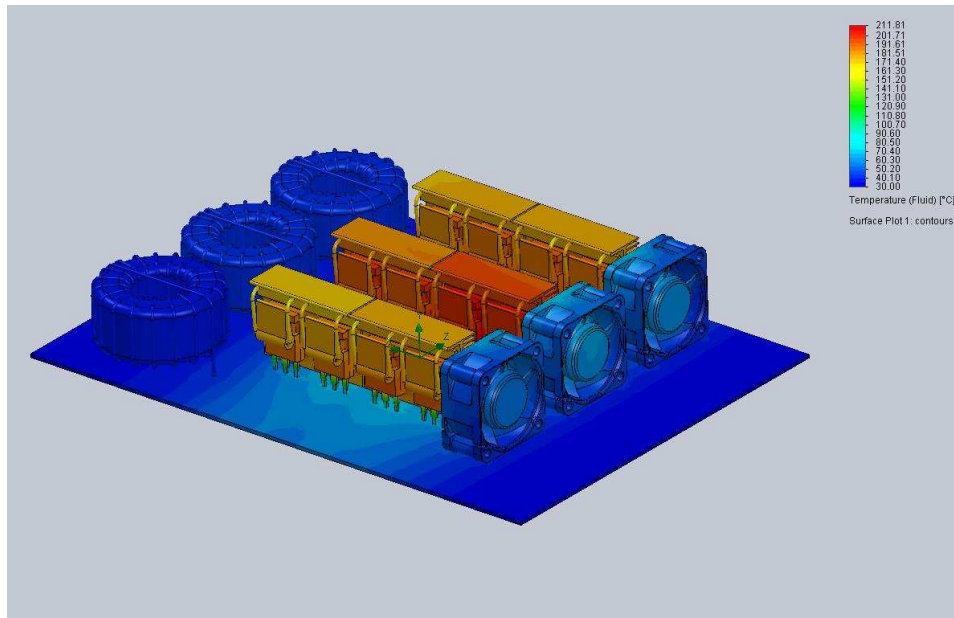
Thermal simulations were performed using the physical layout of the design, as well as the expected energy losses. An off the shelf heat sink from Wakefield-Vette (OMNI-UNI-18-50) was selected to simplify the design process and provide a starting reference point for understanding the thermal performance. This data should be used as a starting point for a thermal solution, and not a fully validated solution.

The system was simulated using a worse than calculated thermal output of 10 W per switching device. This meant 120 W of total power dissipation across all three phases. Figure 34 and Figure 35 show the thermal simulation results with no fans.

Figure 34. Simulated Temperature vs Time

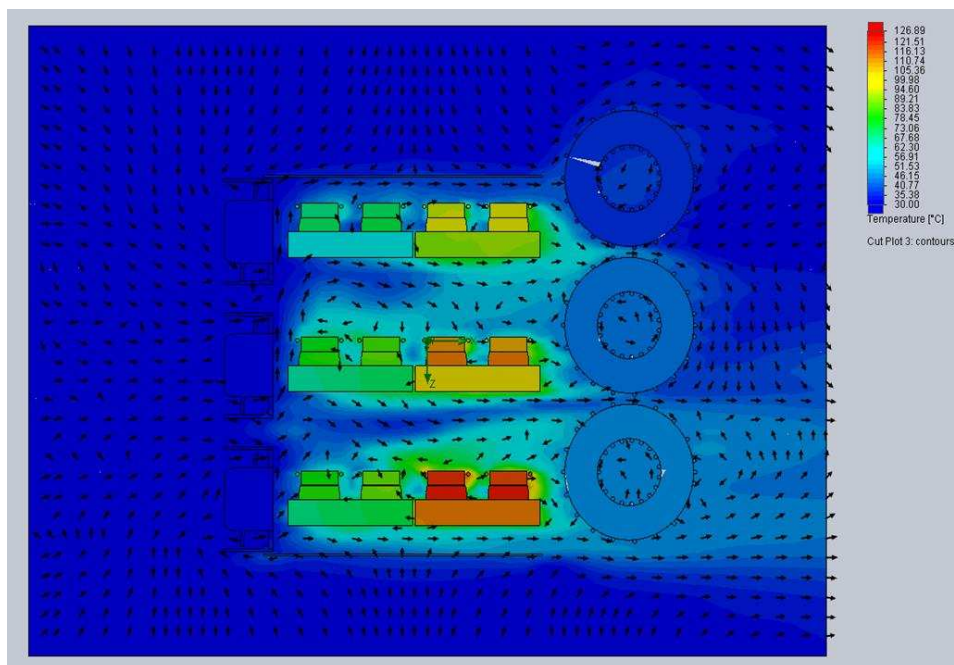


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Figure 35. Passive Thermal Simulation Result


In this simulation, with only natural convection and small off the shelf heat sinks, the TO-247 package of the IGBTs reaches a maximum temperature of 215°C, and the SiC MOSFET reaches 197°C. These temperatures are both outside the maximum allowed temperature range of the devices.

Figure 36 shows the next simulation, which includes active airflow and full ducting of the heat generating devices. This airflow reduces the maximum temperature of the MOSFET under a 130% load to be 130°C. This temperature is within the design constraint of the 175°C junction temperature of the IKW20N60TFKSA1, which is the major heat generator.

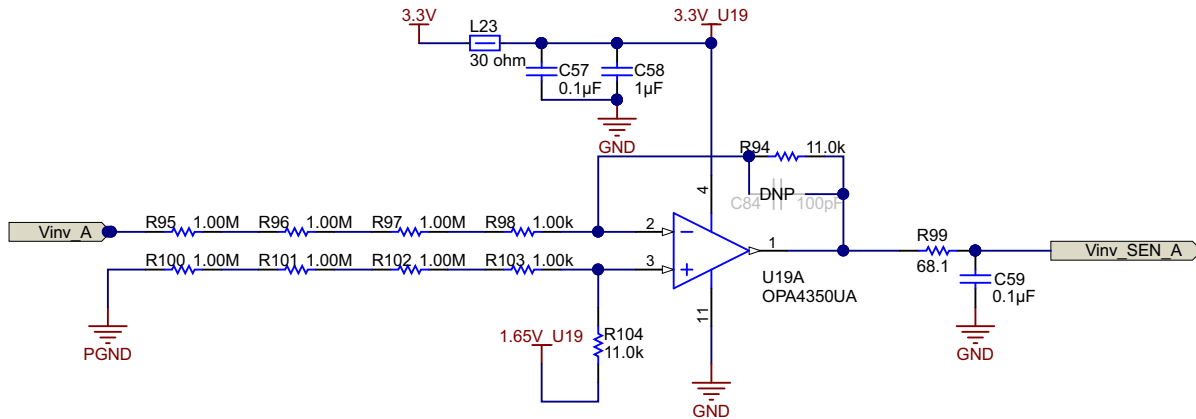
Figure 36. Active Ducted Thermal Simulation


2.3.2 AC Voltage Sensing

Voltage sensing happens at two points in the signal path of the converter to aid in control: before and after the primary output relay. By enabling measurement on both sides of the relay, the control system can lock into the grid voltage and frequency before connecting, thus preventing any mismatch issues.

Both sensing topologies are similar. First, PGND is used as a virtual neutral using a resistor network. On the grid side of the relay, only neutral is used. The high voltage signal is attenuated using a series of large value resistances. An offset of 1.65 V is added to the attenuated neutral point to center the voltage signal in the middle of the input range of the OPA4350, and the attenuated value from the phase voltage is measured. Figure 37 shows this sensing arrangement.

Figure 37. High-Voltage Sensing Signal Path



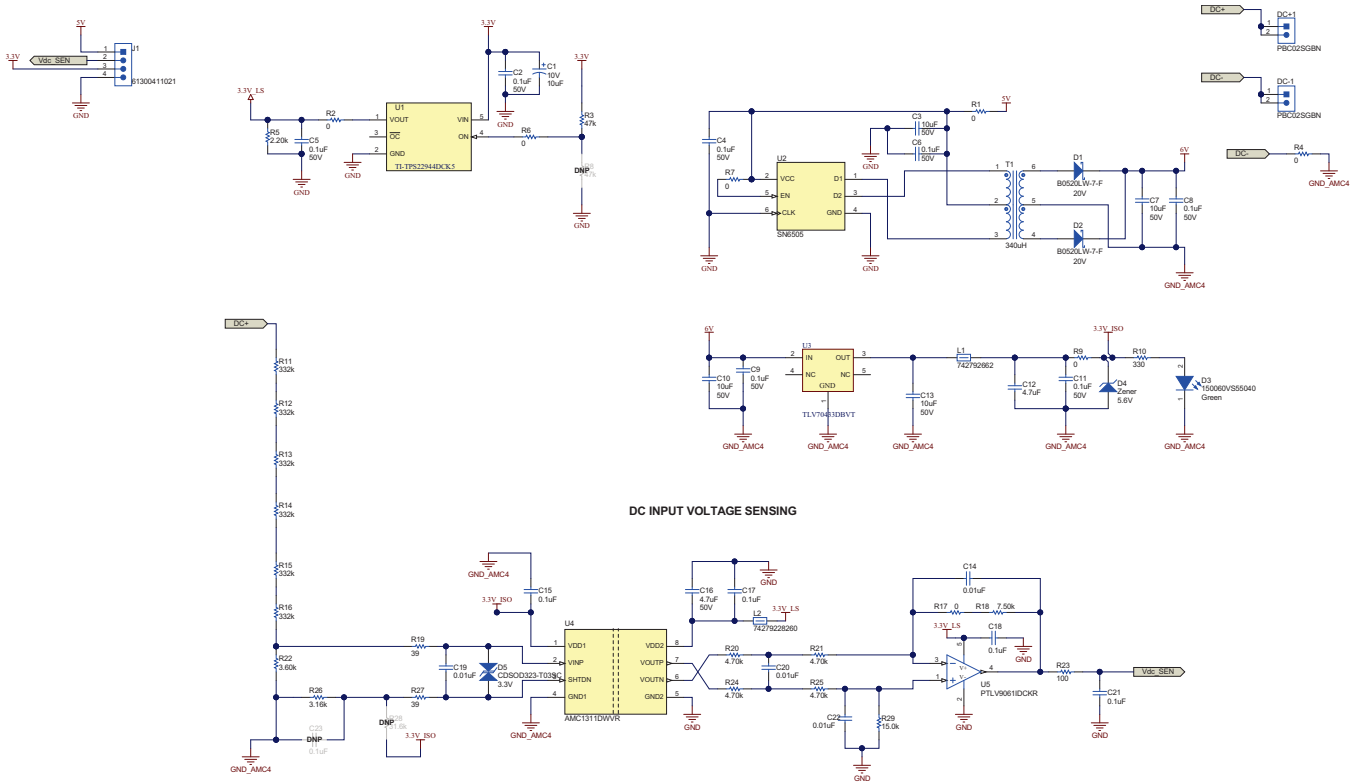
2.3.3 DC Voltage Sensing

The design implements undervoltage and overvoltage protections on the DC bus by measuring DC-Link voltage. The DC bus input voltage is scaled down and fed to the MCU using the AMC1311 reinforced isolation amplifier, and the op amp OPA320. The output of the OPA320 can directly drive an ADC input or can be further filtered before processed by the ADC.

To scale down the DC-Link voltage, a resistor divider network is chosen considering the maximum voltage for the MCU ADC input as 3 V and the maximum DC-Link voltage to be measured as 1026 V.

To achieve better linearity and the noise performance of the device, the allowable input voltage is from 0 to 2 V. The voltage divider resistor is selected such that input voltage to the amplifier is less than 2 V at maximum DC bus condition. Figure 38 shows six 1-MΩ resistors and an 11-kΩ resistor used to drop the VDC signal.

Figure 38. DC Link Voltage Sensing



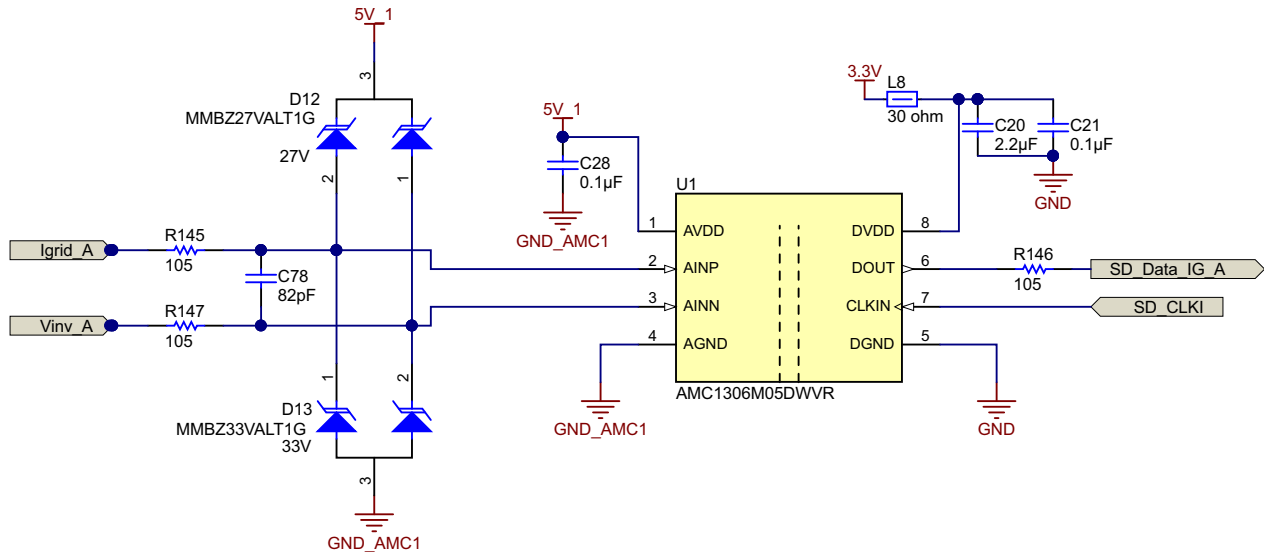
2.3.4 Current Sensing

Critical to getting a closed loop control system is accurate current measurement of the power stage. In this design, current measurement is done at two locations with different sensing technologies. The first location is on the grid side using shunt resistors. Because the output is high voltage and the controller needs to remain isolated, the AMC1306M05 reinforced modulator is used to measure the resistor voltage drop. To keep system losses low, the AMC1306M05 has a $\pm 50\text{-mV}$ input range. When compared to other devices with a typical input range of $\pm 250\text{ mV}$, the total power loss across the shunt is significantly reduced.

Sizing the shunt resistor for this design is a trade-off between sensing accuracy and power dissipation. A $0.001\text{-}\Omega$ shunt provides a $\pm 20\text{-mV}$ output signal at the approximate $\pm 20\text{-A}$ grid current of the converter but also only generates 0.4 W of heat at full load. When choosing an actual device, select a high accuracy value to eliminate the need to calibrate each sensor path.

The voltage across the shunt resistor is fed into the AMC1306M05 sigma-delta modulator, which generates the sigma-delta stream that is decoded by the SDFM demodulator present on the C2000™ MCU. The clock for the modulator is generated from the ECAP peripheral on the C2000 MCU, and the AMC1306M05 data is decoded using the built-in SDFM modulator.

Figure 39. Isolated Shunt Sensing With AMC1305M05



The second location is a Hall effect sensor, which is used to sense the current through the inductor. The Hall effect sensor has a built-in offset, and the range is different than what ADC can measure. Therefore, the voltage is scaled to match the ADC range using the circuit shown in Figure 41 and Equation 32. Of note here, the OPA4340 is used over the OPA4350 in the voltage sense path due to the lower bandwidth of the former. The low bandwidth helps to reduce accidental amplification of switching noise that might be picked up by long traces in the PCB.

Figure 40. Isolated Hall Effect Current Sensing

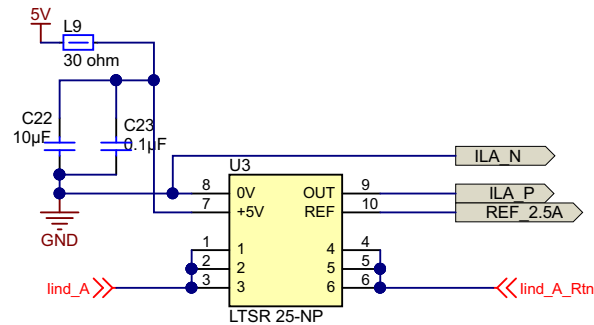
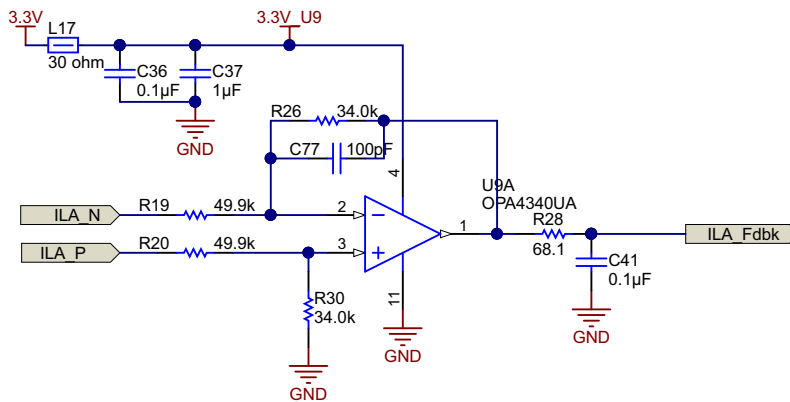


Figure 41. Hall Effect Sensor Matching



$$V_{out} = \frac{R_f}{R_e} \left(\frac{V_{nominal}}{I_{max}} + V_{offset} \right)$$

(32)

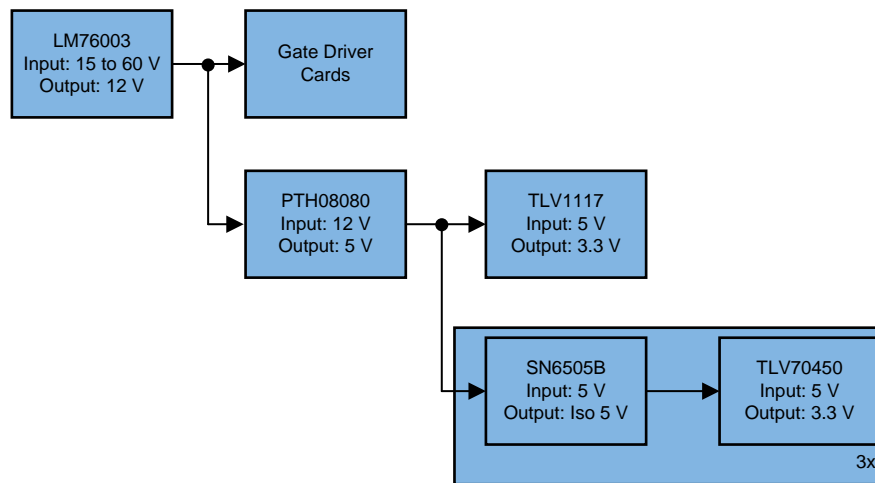
2.3.5 System Power Supplies

This reference design uses multiple voltage domains across the system:

- A primary high-voltage input to power the entire board (up to 60 V)
- 12 V to power the gate drive cards, further described in [Section 2.3.6](#)
- 5 V to power the control card and drive isolated supplies
- Non-isolated 3.3 V for analog sensing
- Isolated 3.3 V for current shunt sensing

Figure 42 shows the full tree for all of these domains.

Figure 42. Power Tree

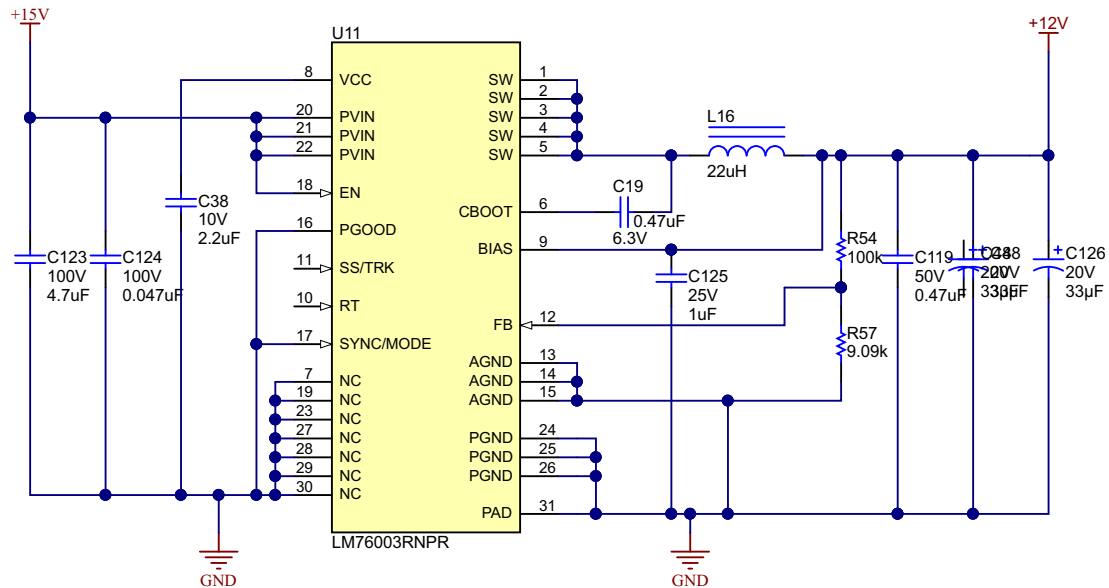


2.3.5.1 Main Input Power Conditioning

The primary voltage input for the design is rated for 15 V to 60 V. This wide V_{IN} enables the converter to be powered from a variety of industrial voltage sources that might be used in a larger system. The range is enabled by the LM76003 synchronous step-down converter.

The converter is configured for a 12-V output using the R54 and R57 feedback resistor divider. This 12-V rail is then used to power the relays, fans, isolated gate drive bias supplies, and the remainder of the step-down converters in the system. The 3.5-A output support of the LM76003 is sufficient for this operation. The design also includes dual parallel output capacitors to reduce ESR and subsequent ripple and load transients and loads switch on an off.

Figure 43. LM76003 12-V DC/DC Converter



2.3.5.2 Isolated Bias Supplies

To generate the isolated bias supplies for the AMC1306M05 isolated modulators, the SN6505B transformer driver is used to drive a Würth 750313638 transformer in a push-pull configuration. This is a recommended configuration from the SN6505B data sheet to build a 5-V → 6-V isolated supply.

The 6-V output is used to feed a TLV70450 LDO to generate a clean 5-V rail for the analog and digital circuitry of the AMC1306M05.

Figure 44. SN6505 Bias Voltage Supply

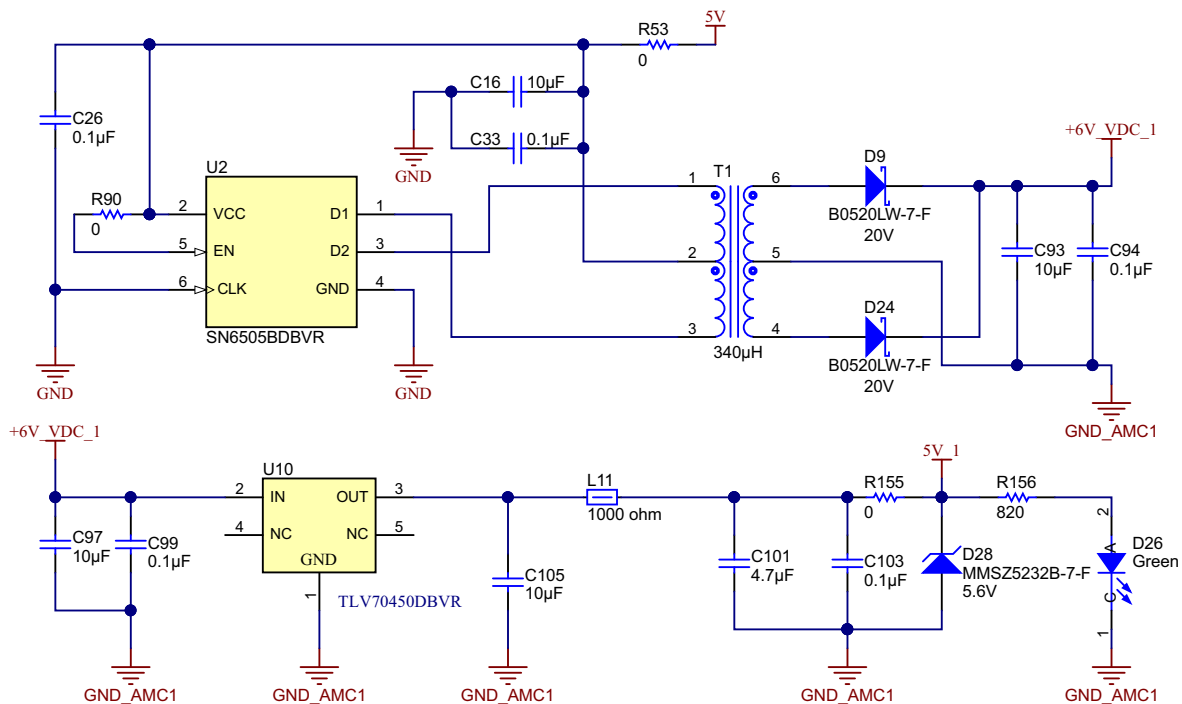
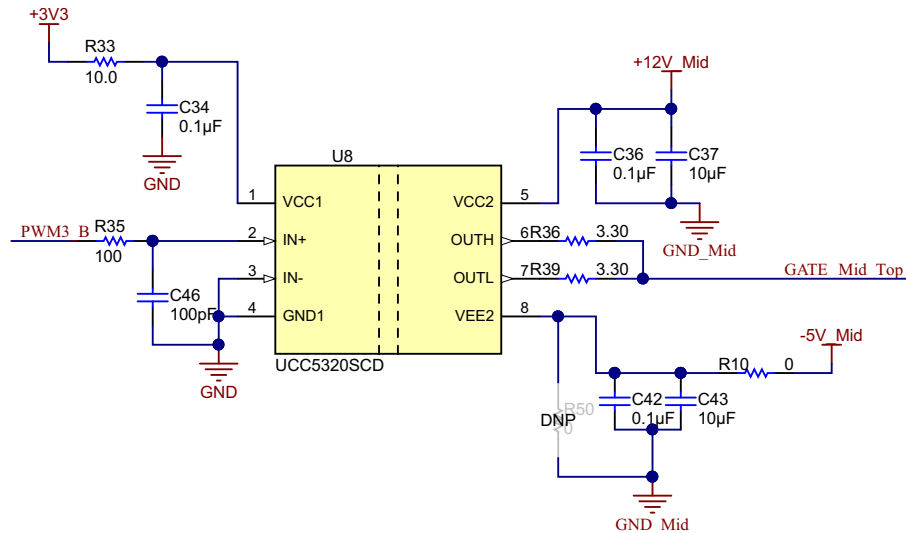
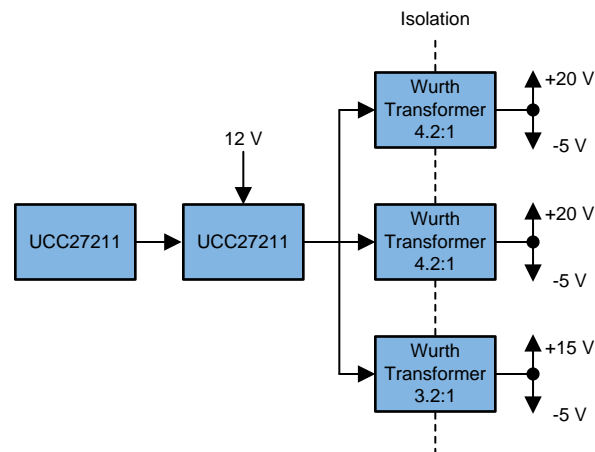


Figure 46. UCC5320 Gate Drive Circuit



2.3.6.3 Gate Driver Bias Supply

Figure 47. Gate Driver Bias Supply Architecture



Section 2.3.6.1 and Section 2.3.6.2 show that the gate drivers rely on isolated bias voltages to drive the gates across the high-voltage barrier. In this architecture, there are four drivers per phase, but only three isolated domains are needed as described in Section 2.3.1.1. These domains are:

1. +20 V and –5 V for high SiC MOSFET switch
2. +20 V and –5 V for low SiC MOSFET switch
3. +15 V and –5 V for both IGBTs in the neutral leg

The same architecture used in Section 2.3.5.2 could generate the domains individually. However, with the close proximity of all of the gates on the daughter cards, it makes more sense to use a central controller and distributed isolation transformers.

The UCC27211 uses a dual PWM input from the control card to drive a half bridge comprised of two CDS88537ND MOSFETs. These two FETs are capable of driving the 12-V source from the main power supply to the low side of all three isolation transformers. The transformers have been designed to operate with an open loop control signal of 500 kHz and have appropriate turn ratios to generate the required voltage rails for each gate driver. This architecture decreases system complexity, cost, and size.

3 Hardware, Software, Testing Requirements, and Test Results

3.1 Required Hardware and Software

3.1.1 Hardware

The DUT in this design is set up and operated in several pieces:

- One TIDA-010039 power board
- Three TIDA-010039 gate driver card
- One TIDA-010039 HV Card
- [TMS320F28379D Control Card](#)
- Mini USB cable
- Laptop or other computer

The test equipment required to power and evaluate the design is as follows:

- 15-V/4-A bench style supply for primary board power
- > 10kW DC Load
- > 10-kVA AC Source
- Four-channel, power quality analyzer

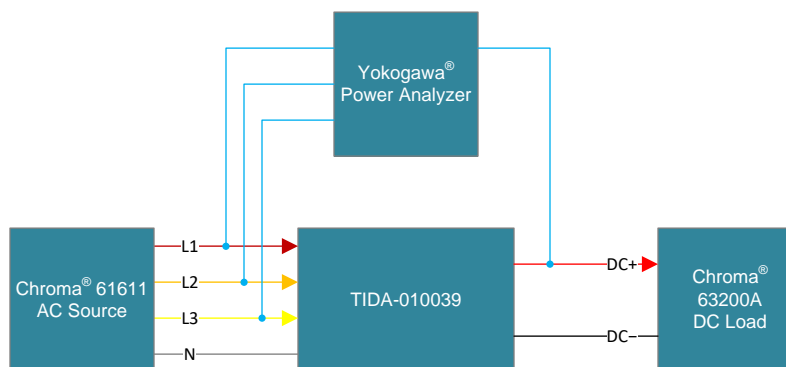
3.1.2 Software

- Code Composer Studio™ 7.x with TI C2000 powerSUITE

3.2 Testing and Results

3.2.1 Test Setup

Figure 48. Test Setup for Efficiency



To test the efficiency of this reference design, use the following equipment:

- Chroma® 61611 AC source
- Chroma® 63200A DC load
- Yokogawa® Power Quality Analyzer

The system is configured to operate in an open loop control mode, generating a static 800-V output. The power demand is then modulated by the Chroma load bank to test the system at multiple load points.

Table 3 lists the system efficiency results from the power scope. The results demonstrate a converter with a maximum efficiency of 97.96%.

The final design dimensions are outlined in Table 4 and show a total volume of 7L. With a power rating of 10 kW, this results in a power density of 1.44 kW/L.

3.2.2 Test Results

Table 3. System Efficiency Results

LOAD	10%	20%	30%	40%	50%	60%	70%	80%	90%	100%
EFFICIENCY	93.67%	96.96%	97.91%	97.94%	97.93%	97.94%	97.96%	97.81%	97.34%	97.25%

Figure 49. Converter Efficiency

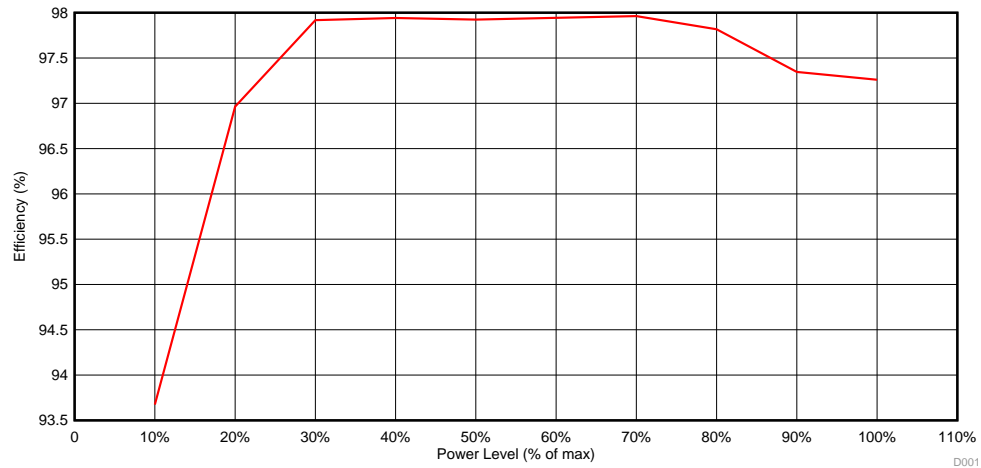


Table 4. System Dimensions

AXIS	DIMENSION
X	350 mm
Y	200 mm
Z	100 mm
Volume	7 liters

The total energy density of the design is 10 kW/7L, or 1.43 kW/L.

4 Design Files

4.1 Schematics

To download the schematics, see the design files at [TIDA-010039](#).

4.2 Bill of Materials

To download the bill of materials (BOM), see the design files at [TIDA-010039](#).

4.3 PCB Layout Recommendations

4.3.1 Layout Prints

To download the layer plots, see the design files at [TIDA-010039](#).

4.4 Altium Project

To download the Altium Designer® project files, see the design files at [TIDA-010039](#).

4.5 Gerber Files

To download the Gerber files, see the design files at [TIDA-010039](#).

4.6 Assembly Drawings

To download the assembly drawings, see the design files at [TIDA-010039](#).

5 Related Documentation

1. Texas Instruments, [Isolated IGBT Gate Driver Evaluation Platform for 3-Phase Inverter System](#)
2. Texas Instruments, [Other Reference Materials](#)

6 Trademarks

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